



A25LQ080A Series

Ultra Low Power, 8M-bit

Preliminary

Serial Multi I/O Flash Memory

Document Title

Ultra Low Power, 8M-bit Serial Multi I/O Flash Memory

Revision History

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A25LQ080A Series

Ultra Low Power, 8M-bit Serial Multi I/O Flash Memory

Preliminary

FEATURES

- 8M-bit Serial Flash
 - 1024K-Byte
 - 256 Bytes per programmable page
- Standard, Dual, Quad SPI
 - Standard SPI: C, \overline{S} , DI, DO, \overline{W} , \overline{HOLD}
 - Dual SPI: C, \overline{S} , IO₀, IO₁, \overline{W} , \overline{HOLD}
 - Quad SPI: C, \overline{S} , IO₀, IO₁, IO₂, IO₃
- High Speed Clock Frequency
 - 104MHz for fast read with 30pF load
 - Dual I/O Data transfer up to 208Mbits/s
 - Quad I/O Data transfer up to 416Mbits/s
- Software/Hardware Write Protection
 - Write protect all/portion of memory via software
 - Enable/Disable protection with \overline{W} Pin
 - Top/Bottom Block protection
- Minimum 100,000 Program/Erase Cycles
- Data Retention
 - 20-year data retention typical
- Allows XIP (execute in place) Operation
 - Continuous Read With 8/16/32/64-Byte Wrap
- Fast Program/Erase Speed
 - Page Program time: 1.1ms typical
 - Sector Erase time: 2.6ms typical
 - Block Erase time: 2.6ms typical
 - Chip Erase time: 5.2ms typical
- Flexible Architecture
 - Uniform Sector of 4K-Byte
 - Uniform Block of 32/64K-Byte
- Low Power Consumption
 - 0.65uA typical deep power down current
 - 8uA typical standby current
- Advanced Security Features
 - 128-Bit Unique ID for each device
 - 3x1024-Byte security registers with OTP locks
 - Discoverable parameters (SFDP) register
- Single Power Supply Voltage
 - Full voltage range: 2.7V~3.6V
- Package Information
 - DIP8 (300mil)
 - SOP8 (150mil)
 - SOP8 (209mil)
 - USON (2*3mm)
 - WSON8 (6*5mm)
 - All Pb-free (Lead-free) products are RoHS compliant

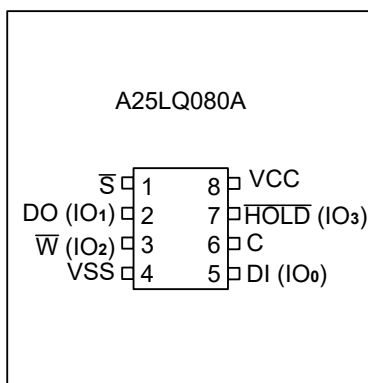
GENERAL DESCRIPTION

The A25LQ080A(8M-bit) Serial flash supports the standard Serial Peripheral Interface (SPI), and supports the Dual/Quad SPI: Serial Clock, Chip Select, Serial Data I/O₀ (DI), I/O₁ (DO),

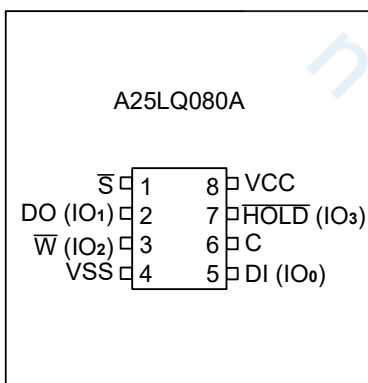
I/O₂ (\overline{W}), and I/O₃ (\overline{HOLD}). The Dual I/O data is transferred with speed of 208Mbits/s and the Quad I/O & Quad output data is transferred with speed of 416Mbits/s.

Pin Configurations

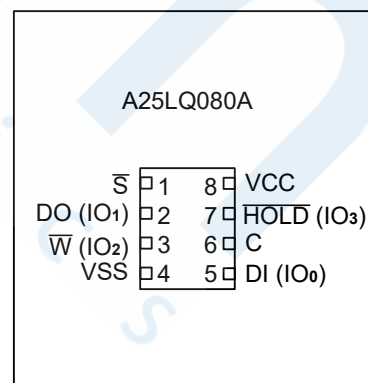
■ DIP8(300mil)



■ SOP8(150mil / 209mil)



■ USON8(2*3mm) / WSON8(6*5mm)



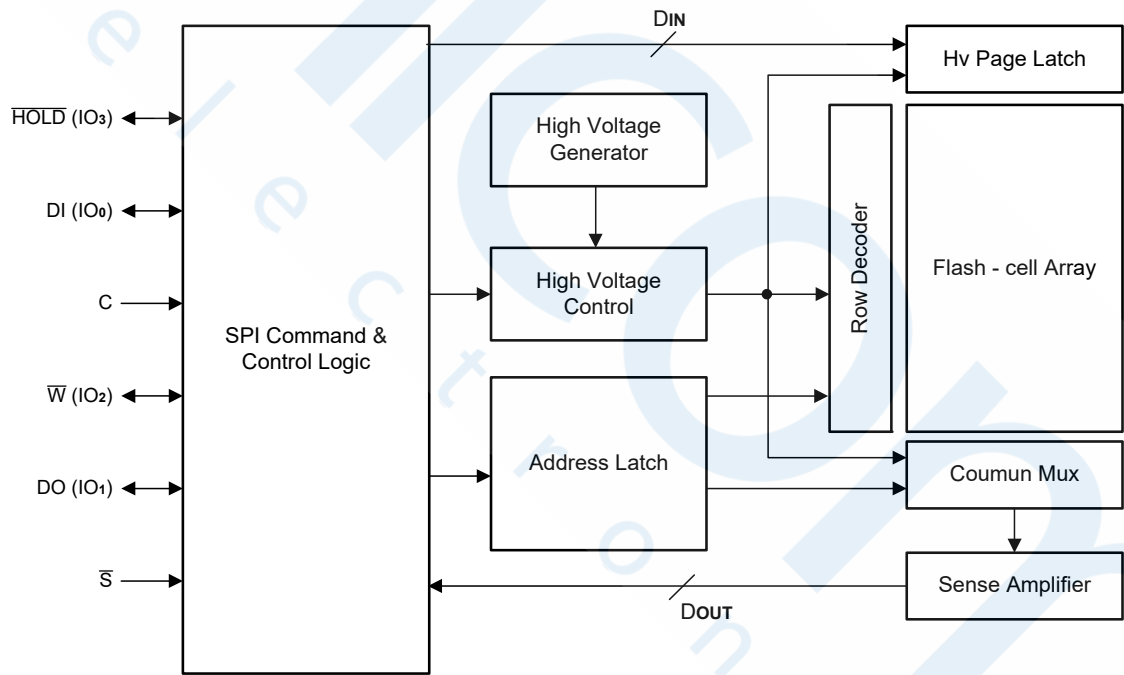


Pin Descriptions

Pin No.	Pin Name	I/O	Description
1	\overline{S}	I	Chip Select Input
2	DO (IO ₁)	I/O	Data Output (Data Input Output 1)
3	\overline{W} (IO ₂)	I/O	Write Protect Input (Data Input Output 2)
4	VSS		Ground
5	DI (IO ₀)	I/O	Data Input (Data Input Output 0)
6	C	I	Serial Clock Input
7	\overline{HOLD} (IO ₃)	I/O	Hold Input (Data Input Output 3)
8	VCC		Power Supply

Notes: \overline{S} must be driven high if chip is not selected. Please don't leave \overline{S} floating any time after power is on.

Block Diagram



MEMORY ORGANIZATION
A25LQ080A

Each device has	Each block has	Each sector has	Each page has	
1M	64/32K	4K	256	bytes
4K	256/128	16	-	pages
256	16/8	-	-	sectors
16/32	-	-	-	blocks

UNIFORM BLOCK SECTOR ARCHITECTURE
A25LQ080A 64K Bytes Block Sector Architecture

Block	Sector	Address range	
15	255	0FF000H	0FFFFFFH

	240	0F0000H	0F0FFFFH
14	239	0EF000H	0EFFFFFFH

	224	0E0000H	0E0FFFFH
.....

.....

2	47	02F000H	02FFFFFFH

	32	020000H	020FFFFH
1	31	01F000H	01FFFFFFH

	16	010000H	010FFFFH
0	15	00F000H	00FFFFFFH

	0	000000H	000FFFFH

DEVICE OPERATION

SPI Mode

Standard SPI

The A25LQ080A features a serial peripheral interface on 4 signals bus: Serial Clock (C), Chip Select (\overline{S}), Serial Data Input (DI) and Serial Data Output (DO). Both SPI bus mode 0 and 3 are supported. Input data is latched on the rising edge of C and data shifts out on the falling edge of C.

Dual SPI

The A25LQ080A supports Dual SPI operation when using the "Dual Output Fast Read" and "Dual I/O Fast Read" (3BH and BBH) commands. These commands allow data to be transferred to or from the device at twice the rate of the standard SPI. When using the Dual SPI command the DI and DO pins become bidirectional I/O pins: IO₀ and IO₁.

Quad SPI

The A25LQ080A supports Quad SPI operation when using the "Quad Output Fast Read" (6BH), "Quad I/O Fast Read" (EBH), "Quad I/O Word Fast Read" (E7H) and "Quad Page Program" (32H) commands. These commands allow data to be transferred to or from the device at four times the rate of the standard SPI. When using the Quad SPI command the DI and DO pins become bidirectional I/O pins: IO₀ and IO₁, and \overline{W} and \overline{HOLD} pins become IO₂ and IO₃.

Quad SPI commands require the non-volatile Quad Enable bit (QE) in Status Register to be set.

Hold

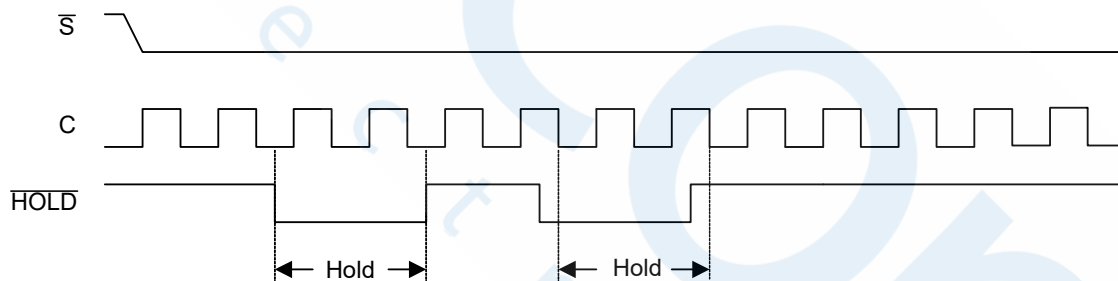
The \overline{HOLD} function is only available when QE=0. If QE=1, The \overline{HOLD} functions is disabled, the pin acts as dedicated data I/O pin.

The \overline{HOLD} signal goes low to stop any serial communications with the device, but doesn't stop the operation of write status register, programming, or erasing in progress.

The operation of \overline{HOLD} , need \overline{S} keep low, and starts on falling edge of the \overline{HOLD} signal, with C signal being low (if C is not being low, \overline{HOLD} operation will not start until C being low). The \overline{HOLD} condition ends on rising edge of \overline{HOLD} signal with C being low (If C is not being low, \overline{HOLD} operation will not end until C being low).

The DO is high impedance, both DI and C don't care during the \overline{HOLD} operation, if \overline{S} drives high during \overline{HOLD} operation, it will reset the internal logic of the device. To re-start communication with chip, the \overline{HOLD} must be at high and then \overline{S} must be at low.

Figure 1. Hold Condition



DATA PROTECTION

The A25LQ080A provides the following data protection methods:

- Write Enable (WREN) command: The WREN command is set the Write Enable Latch bit (WEL). The WEL bit will return to reset by the following situation:
 - Power-Up
 - Write Disable (WRDI)
 - Write Status Register (WRSR)
 - Page Program (PP)
 - Sector Erase 1K (SE1K) / Sector Erase (SE) / Block Erase (BE) / Chip Erase (CE)

- Software Protection Mode: The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits define the section of the memory array that can be read but not change.
- Hardware Protection Mode: \overline{W} goes low to protect the BP0~BP4 bits and SRP0~1 bits.
- Deep Power-Down Mode: In Deep Power-Down Mode, all commands are ignored except the Release from Deep Power-Down Mode command.

Table 1.0 A25LQ080A Protected area size (CMP=0)

Status Register Content					Memory Content			
BP4	BP3	BP2	BP1	BP0	Blocks	Addresses	Density	Portion
X	X	0	0	0	NONE	NONE	NONE	NONE
0	0	0	0	1	15	0F0000H-0FFFFFFH	64KB	Upper 1/16
0	0	0	1	0	14 to 15	0E0000H-0FFFFFFH	128KB	Upper 1/8
0	0	0	1	1	12 to 15	0C0000H-0FFFFFFH	256KB	Upper 1/4
0	0	1	0	0	8 to 15	080000H-0FFFFFFH	512KB	Upper 1/2
0	1	0	0	1	0	000000H-00FFFFH	64KB	Lower 1/16
0	1	0	1	0	0 to 1	000000H-01FFFFH	128KB	Lower 1/8
0	1	0	1	1	0 to 3	000000H-03FFFFH	256KB	Lower 1/4
0	1	1	0	0	0 to 7	000000H-07FFFFH	512KB	Lower 1/2
0	X	1	0	1	0 to 15	000000H-0FFFFFFH	1MB	ALL
X	X	1	1	X	0 to 15	000000H-0FFFFFFH	1MB	ALL
1	0	0	0	1	15	0FF000H-0FFFFFFH	4KB	Top Block
1	0	0	1	0	15	0FE000H-0FFFFFFH	8KB	Top Block
1	0	0	1	1	15	0FC000H-0FFFFFFH	16KB	Top Block
1	0	1	0	X	15	0F8000H-0FFFFFFH	32KB	Top Block
1	1	0	0	1	0	000000H-000FFFFH	4KB	Bottom Block
1	1	0	1	0	0	000000H-001FFFFH	8KB	Bottom Block
1	1	0	1	1	0	000000H-003FFFFH	16KB	Bottom Block
1	1	1	0	X	0	000000H-007FFFFH	32KB	Bottom Block

Table 1.1 A25LQ080A Protected area size (CMP=1)

Status Register Content					Memory Content			
BP4	BP3	BP2	BP1	BP0	Blocks	Addresses	Density	Portion
X	X	0	0	0	0 to 15	000000H-0FFFFFFH	1M	ALL
0	0	0	0	1	0 to 14	000000H-0EFFFFH	960KB	Lower 15/16
0	0	0	1	0	0 to 13	000000H-0DFFFFH	896KB	Lower 7/8
0	0	0	1	1	0 to 11	000000H-0BFFFFH	768KB	Lower 3/4
0	0	1	0	0	0 to 7	000000H-07FFFFH	512KB	Lower 1/2
0	1	0	0	1	1 to 15	010000H-0FFFFFFH	960KB	Upper 15/16
0	1	0	1	0	2 to 15	020000H-0FFFFFFH	896KB	Upper 7/8
0	1	0	1	1	4 to 15	040000H-0FFFFFFH	768KB	Upper 3/4
0	1	1	0	0	8 to 15	080000H-0FFFFFFH	512KB	Upper 1/2
0	X	1	0	1	NONE	NONE	NONE	NONE
X	X	1	1	X	NONE	NONE	NONE	NONE
1	0	0	0	1	0 to 15	000000H-0FEFFFFH	1020KB	Lower 255/256
1	0	0	1	0	0 to 15	000000H-0FDFFFFH	1016KB	Lower 127/128
1	0	0	1	1	0 to 15	000000H-0FBFFFFH	1008KB	Lower 63/64
1	0	1	0	X	0 to 15	000000H-0F7FFFFH	992KB	Lower 31/32
1	1	0	0	1	0 to 15	001000H-0FFFFFFH	1020KB	Upper 255/256
1	1	0	1	0	0 to 15	002000H-0FFFFFFH	1016KB	Upper 127/128
1	1	0	1	1	0 to 15	004000H-0FFFFFFH	1008KB	Upper 63/64
1	1	1	0	X	0 to 15	008000H-0FFFFFFH	992KB	Upper 31/32

STATUS REGISTER

S15	S14	S13	S12	S11	S10	S9	S8
SUS1	CMP	LB3	LB2	LB1	SUS2	QE	SRP1

S7	S6	S5	S4	S3	S2	S1	S0
SRP0	BP4	BP3	BP2	BP1	BP0	WEL	WIP

The status and control bits of the Status Register are as follows:

WIP bit.

The Write in Progress (WIP) bit indicates whether the memory is busy in program/erase/write status register progress. When WIP bit sets to 1, means the device is busy in program/erase/write status register progress, when WIP bit sets 0, means the device is not in program/erase/write status register progress.

WEL bit.

The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch. When set to 1 the internal Write Enable Latch is set, when set to 0 the internal Write Enable Latch is reset and no Write Status Register, Program or Erase command is accepted.

BP4, BP3, BP2, BP1, BP0 bits.

The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits are non-volatile. They define the size of the area to be software protected against Program and Erase commands. These bits are written with the Write Status Register (WSR) command. When the Block Protect (BP4, BP3, BP2, BP1, BP0) bits are set to 1, the relevant memory area (as defined in Table1), becomes protected against Page Program (PP), Sector Erase (SE), 1K Sector Erase (SE1K), 32K Block Erase (BE32) and 64K Block Erase (BE64) commands. The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits can be written provided that the Hardware Protected mode has not been set. The Chip Erase (CE) command is executed, if the Block Protect (BP2, BP1, and BP0) bits are 0 and CMP=0 or the Block Protect (BP2, BP1, and BP0) bits are 1 and CMP=1.

SRP1, SRP0 bits.

The Status Register Protect (SRP1 and SRP0) bits are non-volatile Read/Write bits in the status register. The SRP bits control the method of write protection: software protection, hardware protection, power supply lock-down or one time programmable protection.

SRP1	SRP0	\overline{W}	Status Register	Description
0	0	X	Software Protected	The Status Register can be written to after a Write Enable command, WEL=1.(Default)
0	1	0	Hardware Protected	\overline{W} =0, the Status Register locked and cannot be written to.
0	1	1	Hardware Unprotected	\overline{W} =1, the Status Register is unlocked and can be written to after a Write Enable command, WEL=1.

SRP1	SRP0	\overline{W}	Status Register	Description
1	0	X	Power Supply Lock-Down ⁽¹⁾	Status Register is protected and cannot be written to again until the next Power-Down, Power-Up cycle.
1	1	X	One Time Program ⁽²⁾	Status Register is permanently protected and cannot be writtentto.

Notes:

1. When SRP1, SRP0= (1, 0), a Power-Down, Power-Up cycle will change SRP1, SRP0 to (0, 0) state.
2. This feature is available on special order. Please contact AMIC Device for details.

QE bit.

The Quad Enable (QE) bit is a non-volatile Read/Write bit in the Status Register that allows Quad operation. When the QE bit is set to 0 (Default) the \overline{W} pin and \overline{HOLD} pin are enable. When the QE pin is set to 1, the Quad IO₂ and IO₃ pins are enabled. (It is best to set the QE bit to 0 to avoid short issues if the \overline{W} or \overline{HOLD} pin is tied directly to the power supply or ground).

LB3, LB2, LB1 bit.

The LB3, LB2, and LB1 bit is a non-volatile One Time Program (OTP) bit in Status Register (S13-S11) that provide the write protect control and status to the Security Registers. The default state of LB3, LB2, and LB1 is 0, the security registers are unlocked. LB3, LB2, and LB1 can be set to 1 individually using the Write Register instruction. LB3, LB2, and LB1 is One Time Programmable, once it's set to 1, the Security Registers will become read-only permanently.

CMP bit

The CMP bit is a non-volatile Read/Write bit in the Status Register (S14). It is used in conjunction with the BP4-BP0 bits to provide more flexibility for the array protection. Please see the Status registers Memory Protection table for details. The default setting is CMP=0.

SUS1, SUS2 bit

The SUS1 and SUS2 bits are read only bits in the status register (S15, S10) that is set to 1 after executing an Erase/Program Suspend (75H) command. SUS1 will be set 1 for erase suspend, and SUS2 will be set 1 for program suspend. The SUS1 and SUS2 bits will be cleared to 0 by Erase/Program Resume (7AH) command as well as a power-down, power- up cycle.

COMMANDS DESCRIPTION

All commands, addresses and data are shifted in and out of the device, beginning with the most significant bit on the first rising edge of C after \overline{S} is driven low. Then, the one-Byte command code must be shifted in to the device, with most significant bit first on DI, and each bit is latched on the rising edges of C.

See Table 2, every command sequence starts with a one-Byte command code. Depending on the command, this might be followed by address Bytes, or by data Bytes, or by both or none. \overline{S} must be driven high after the last bit of the command sequence has been completed. For the commands of Read, Fast Read, Read Status Register or Release from Deep Power-Down, and Read Device ID, the shifted-in command sequence is followed by a data-out sequence. All read instruction can be completed after any

bit of the data-out sequence is being shifted out, and then \overline{S} must be driven high to return to deselected status.

For the commands of Page Program, Sector Erase, Block Erase, Chip Erase, Write Status Register, Write Enable, Write Disable or Deep Power-Down command, \overline{S} must be driven high exactly at a Byte boundary, otherwise the command is rejected, and is not executed. That means \overline{S} must be driven high when the number of clock pulses after \overline{S} being driven low is an exact multiple of eight. For Page Program, if \overline{S} is driven high at any time the input Byte is not a full Byte, nothing will happen and WEL will not be reset.

Table 2. Commands (Standard/Dual/Quad SPI)

Command Name	Byte 1	Byte 2	Byte 3	Byte 4	Byte 5	Byte 6	n-Bytes
Write Enable	06H						
Write Disable	04H						
Volatile SR Write Enable	50H						
Read Status Register	05H	(S7-S0)					(continuous)
Read Status Register-1	35H	(S15-S8)					(continuous)
Write Status Register	01H	S7-S0	S15-S8				
Read Data	03H	A23-A16	A15-A8	A7-A0	(D7-D0)	(Next Byte)	(continuous)
Fast Read	0BH	A23-A16	A15-A8	A7-A0	dummy	(D7-D0)	(continuous)
Dual Output Fast Read	3BH	A23-A16	A15-A8	A7-A0	dummy	(D7-D0) ⁽¹⁾	(continuous)
Dual I/O Fast Read	BBH	A23-A8 ⁽²⁾	A7-A0 M7-M0 ⁽²⁾	(D7-D0) ⁽¹⁾			(continuous)
Quad Output Fast Read	6BH	A23-A16	A15-A8	A7-A0	dummy	(D7-D0) ⁽³⁾	(continuous)
Quad I/O Fast Read	EBH	A23-A0 M7-M0 ⁽⁴⁾	dummy ⁽⁵⁾	(D7-D0) ⁽³⁾			(continuous)
Quad I/O Word Fast Read ⁽¹⁾	E7H	A23-A0 M7-M0 ⁽⁴⁾	dummy ⁽⁶⁾	(D7-D0) ⁽³⁾			(continuous)
Continuous Read Mode Reset	FFH						
Page Program	02H	A23-A16	A15-A8	A7-A0	D7-D0	Next Byte	
Dual Input Page Program	A2H	A23-A16	A15-A8	A7-A0	D7-D0		
Quad Page Program	32H	A23-A16	A15-A8	A7-A0	D7-D0		
Sector Erase(1K)	8BH	A23-A16	A15-A8	A7-A0			
Sector Erase(4k)	20H	A23-A16	A15-A8	A7-A0			
Block Erase(32K)	52H	A23-A16	A15-A8	A7-A0			
Block Erase(64K)	D8H	A23-A16	A15-A8	A7-A0			
Chip Erase	C7/60H						
Enable Reset	66H						
Reset	99H						
Program/Erase Suspend	75/B0H						
Program/Erase Resume	7A/30H						
Deep Power-Down	B9H						
Release From Deep Power-Down, And Read Device ID	ABH	dummy	dummy	dummy	(DID7-DID0)		(continuous)

Command Name	Byte 1	Byte 2	Byte 3	Byte 4	Byte 5	Byte 6	n-Bytes
Release From Deep Power-Down	ABH						
Manufacturer/Device ID	90H	dummy	dummy	00H	(MID7-MID0)	(DID7-DID0)	(continuous)
Manufacturer/ Device ID by Dual I/O	92H	A23-A8	A7-A0, M7-M0	(MID7-MID0) (DID7-DID0)			(continuous)
Quad Manufacturer/ Device ID by Quad I/O	94H	A23-A0M7-M0	Dummy ⁽⁹⁾ (MID7-MID0) (DID7-DID0)				(continuous)
Read Unique ID	4BH	dummy	dummy	dummy	dummy	(UID7-UID0)	(continuous)
Set burst length	77H	dummy ⁽¹⁰⁾ M7-M0					
Read Serial Flash Discoverable Parameter	5AH	A23-A16	A15-A8	A7-A0	dummy	(D7-D0)	(continuous)
Read Identification	9FH	(MID7- M0)	(JDID15-JDID8)	(JDID7-JDID0)			(continuous)
Erase SecurityRegisters ⁽⁸⁾	44H	A23-A16	A15-A8	A7-A0			
Program Security Registers ⁽⁸⁾	42H	A23-A16	A15-A8	A7-A0	D7-D0	D7-D0	
Read SecurityRegisters ⁽⁸⁾	48H	A23-A16	A15-A8	A7-A0	dummy	(D7-D0)	

Notes:
1. Dual Output data
 $IO_0 = (D6, D4, D2, D0) \quad IO_1 = (D7, D5, D3, D1)$
2. Dual Input Address
 $IO_0 = A22, A20, A18, A16, A14, A12, A10, A8 \quad A6, A4, A2, A0, M6, M4, M2, M0$
 $IO_1 = A23, A21, A19, A17, A15, A13, A11, A9 \quad A7, A5, A3, A1, M7, M5, M3, M1$
3. Quad Output Data
 $IO_0 = (D4, D0, \dots)$
 $IO_1 = (D5, D1, \dots)$
 $IO_2 = (D6, D2, \dots)$
 $IO_3 = (D7, D3, \dots)$
4. Quad Input Address
 $IO_0 = A20, A16, A12, A8, A4, A0, M4, M0 \quad IO_1 = A21, A17, A13, A9, A5, A1, M5, M1$
 $IO_2 = A22, A18, A14, A10, A6, A2, M6, M2 \quad IO_3 = A23, A19, A15, A11, A7, A3, M7, M3$
5. Fast Read Quad I/O Data
 $IO_0 = (x, x, x, x, D4, D0, \dots)$
 $IO_1 = (x, x, x, x, D5, D1, \dots)$
 $IO_2 = (x, x, x, x, D6, D2, \dots)$
 $IO_3 = (x, x, x, x, D7, D3, \dots)$
6. Fast Word Read Quad I/O Data
 $IO_0 = (x, x, D4, D0, \dots)$
 $IO_1 = (x, x, D5, D1, \dots)$
 $IO_2 = (x, x, D6, D2, \dots)$
 $IO_3 = (x, x, D7, D3, \dots)$
7. Fast Word Read Quad I/O Data: the lowest address bit must be 0.
8. Security Registers Address:

Security Register1: A23-A16=00H, A15-A12=01H, A11-A10=0H, A9-A0= Byte Address;

Security Register2: A23-A16=00H, A15-A12=02H, A11-A10=0H, A9-A0= Byte Address;

Security Register3: A23-A16=00H, A15-A12=03H, A11-A10=0H, A9-A0= Byte Address.

9. Address, Continuous Read Mode bits, Dummy bits, Manufacture ID and Device ID

IO₀ = (A20, A16, A12, A8, A4, A0, M4, M0, x, x, x, x, MID4, MID0, DID4, DID0, ...)

IO₁ = (A21, A17, A13, A9, A5, A1, M5, M1, x, x, x, x, MID5, MID1, DID5, DID1, ...)

IO₂ = (A22, A18, A14, A10, A6, A2, M6, M2, x, x, x, x, MID6, MID2, DID6, DID2, ...)

IO₃ = (A23, A19, A15, A11, A7, A3, M7, M3, x, x, x, x, MID7, MID3, DID7, DID3, ...)

10. Dummy bits and Wrap Bits

IO₀ = (x, x, x, x, x, x, W4, x)

IO₁ = (x, x, x, x, x, x, W5, x)

IO₂ = (x, x, x, x, x, x, W6, x)

IO₃ = (x, x, x, x, x, x, x, x)

Table of ID Definitions:

A25LQ080A

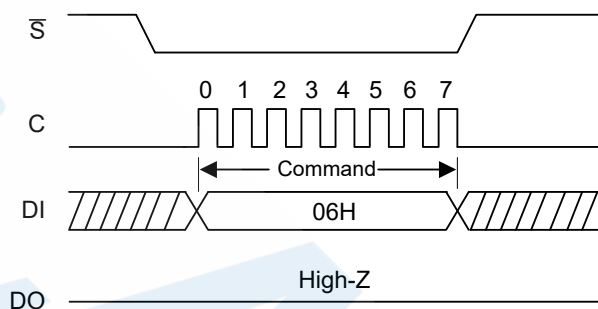
Operation Code	MID7-MID0	ID15-ID8	ID7-ID0
9FH	37	40	14
90H	37		13
ABH			13

Write Enable (WREN) (06H)

The Write Enable (WREN) command is for setting the Write Enable Latch (WEL) bit. The Write Enable Latch (WEL) bit must be set prior to every Page Program (PP), Sector Erase (SE), 1K Sector Erase (SE1K), 32K Block Erase (BE32), 64K Block Erase (BE64), Chip Erase (CE), Write Status

Register (WRSR) and Erase/Program Security Registers command. The Write Enable (WREN) command sequence: \overline{S} goes low sending the Write Enable command \overline{S} goes high.

Figure 2. Write Enable Sequence Diagram

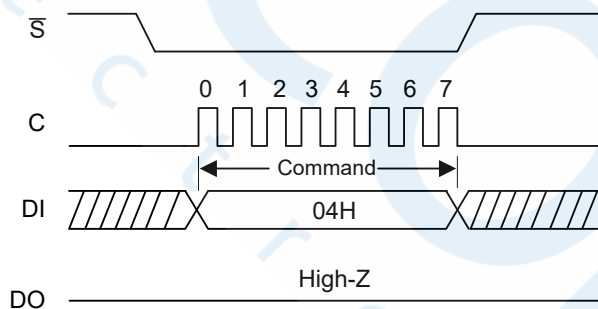


Write Disable (WRDI) (04H)

The Write Disable command is for resetting the Write Enable Latch (WEL) bit. The Write Disable command sequence: \overline{S} goes low Sending the Write Disable command \overline{S} goes high. The WEL bit is reset by following condition: Power- up and upon completion of the Write

Status Register, Page Program, Sector Erase, 1K Sector Erase (SE1K), 32K Block Erase (BE32), 64K Block Erase (BE64), Chip Erase, Erase/Program Security Registers and Reset commands.

Figure 3. Write Disable Sequence Diagram

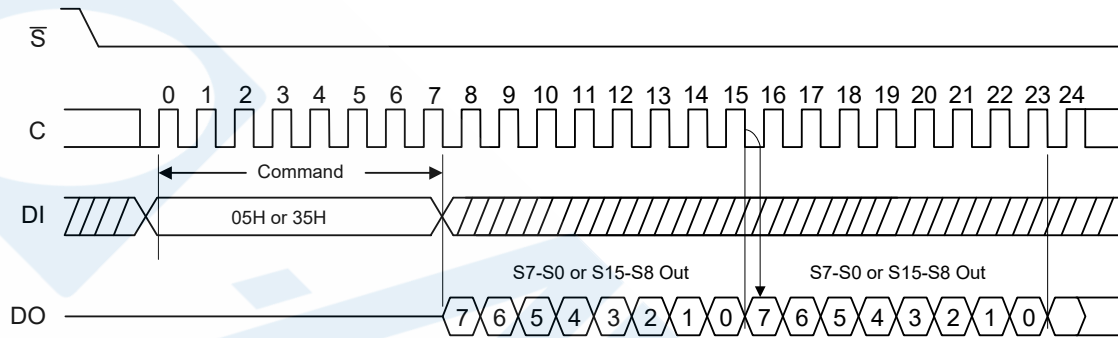


Read Status Register (RDSR) (05H or 35H)

The Read Status Register (RDSR) command is for reading the Status Register. The Status Register may be read at any time, even while a Program, Erase or Write Status Register cycle is in progress. When one of these cycles is in progress, it is recommended to check the Write In Progress (WIP) bit

before sending a new command to the device. It is also possible to read the Status Register continuously. For command code "05H", the DO will output Status Register bits S7~S0. The command code "35H", the DO will output Status Register bits S15~S8.

Figure 4. Read Status Register Sequence Diagram



Write Status Register (WRSR) (01H)

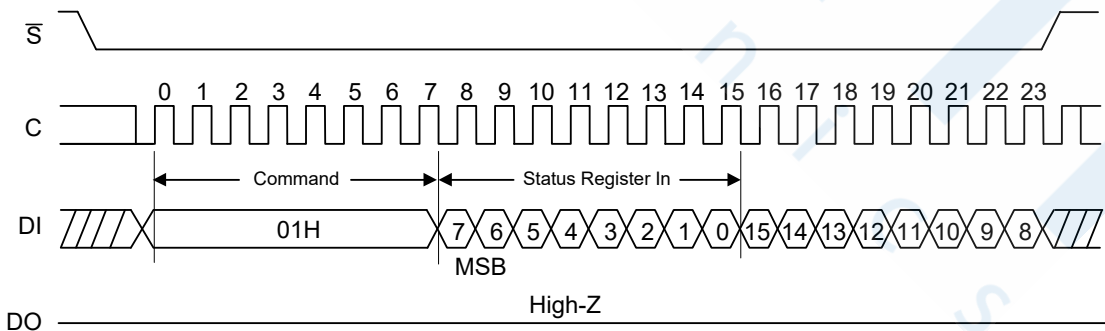
The Write Status Register (WRSR) command allows new values to be written to the Status Register. Before it can be accepted, a Write Enable (WREN) command must previously have been executed. After the Write Enable (WREN) command has been decoded and executed, the device sets the Write Enable Latch (WEL).

The Write Status Register (WRSR) command has no effect on S15, S10, S1 and S0 of the Status Register. \overline{CS} must be driven high after the eighth or sixteen bit of the data Byte has been latched in. If not, the Write Status Register (WRSR) command is not executed. If \overline{CS} is driven high after eighth bit of the data Byte, the CMP and QE bit will be cleared to 0. As soon as \overline{CS} is driven high, the self-timed Write Status Register cycle (whose duration is t_w) is initiated. While the Write Status Register cycle is in progress, the Status Register may still be read to check the value of the

Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Write Status Register cycle, and is 0 when it is completed. When the cycle is completed, the Write Enable Latch (WEL) is reset.

The Write Status Register (WRSR) command allows the user to change the values of the Block Protect (BP4, BP3, BP2, BP1, BP0) bits, to define the size of the area that is to be treated as read-only, as defined in Table1. The Write Status Register (WRSR) command also allows the user to set or reset the Status Register Protect (SRP1, SRP0) bit in accordance with the Write Protect (\overline{WP}) signal. The Status Register Protect (SRP1, SRP0) bit and Write Protect (\overline{WP}) signal allow the device to be put in the Hardware Protected Mode. The Write Status Register (WRSR) command is not executed once the Hardware Protected Mode is entered.

Figure 5. Write Status Register Sequence Diagram

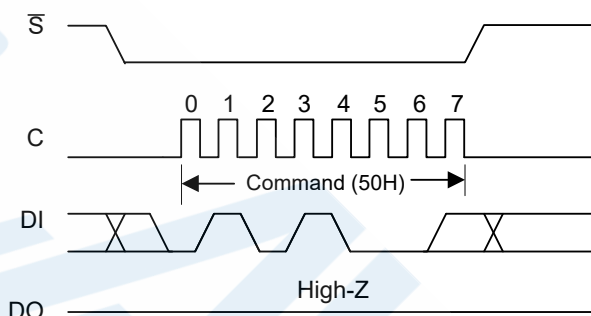


Write Enable for Volatile Status Register (50H)

The non-volatile Status Register bits can also be written to as volatile bits. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits. The Write Enable for Volatile Status Register command must be issued prior to a Write Status

Register command and any other commands can't be inserted between them. Otherwise, Write Enable for Volatile Status Register will be cleared. The Write Enable for Volatile Status Register command will not set the Write Enable Latch bit, it is only valid for the Write Status Register command to change the volatile Status Register bit values.

Figure 6. Write Enable for Volatile Status Register Sequence Diagram

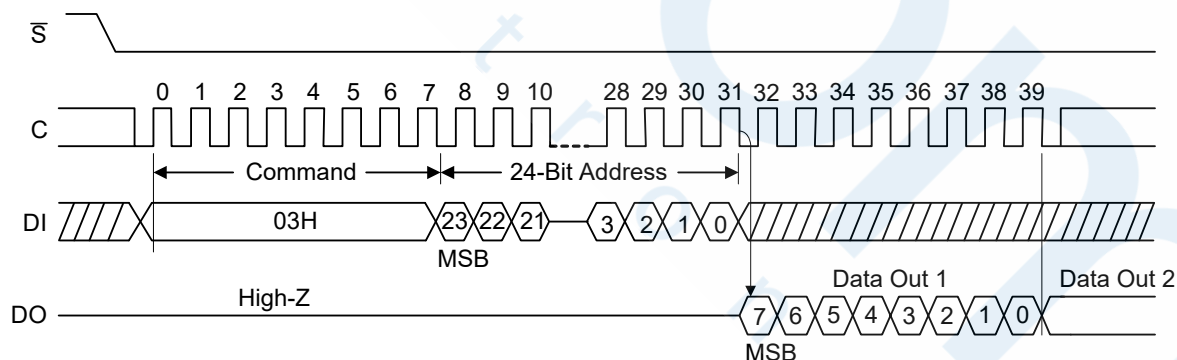


Read Data Bytes (READ) (03H)

The Read Data Bytes (READ) command is followed by a 3-Byte address (A23-A0), and each bit is latched-in on the rising edge of C. Then the memory content at that address is shifted out on DO, and each bit is shifted out at a Max frequency f_R on the falling edge of C. The first Byte addressed can be at any location. The address is

automatically incremented to the next higher address after each Byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes (READ) command. Any Read Data Bytes (READ) command, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

Figure 7. Read Data Bytes Sequence Diagram

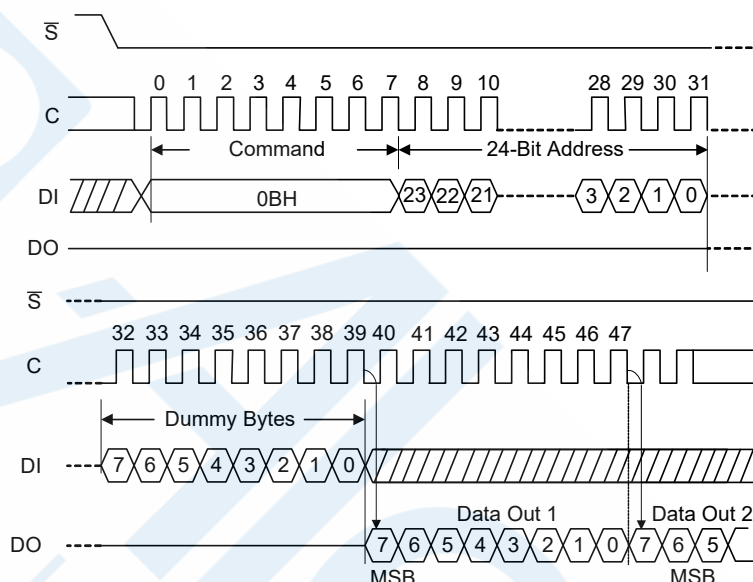


Read Data Bytes at Higher Speed (Fast Read) (0BH)

The Read Data Bytes at Higher Speed (Fast Read) command is for quickly reading data out. It is followed by a 3-Byte address (A23-A0) and a dummy Byte, and each bit is latched-in on the rising edge of C. Then the memory content at that address is shifted out on DO, and each bit is

shifted out at a Max frequency f_c , on the falling edge of C. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out.

Figure 8. Read Data Bytes at Higher Speed Sequence Diagram

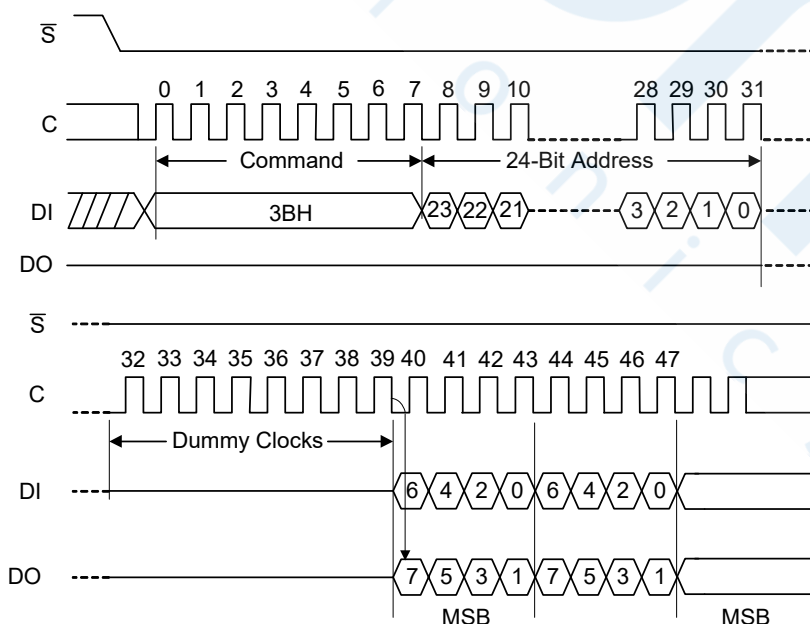


Dual Output Fast Read (3BH)

The Dual Output Fast Read command is followed by 3-Byte address (A23-A0) and a dummy Byte, each bit being latched in during the rising edge of C, then the memory contents are shifted out 2-bit per clock cycle from

DI and DO. The command sequence is shown in followed Figure 9 The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out.

Figure 9. Dual Output Fast Read Sequence Diagram

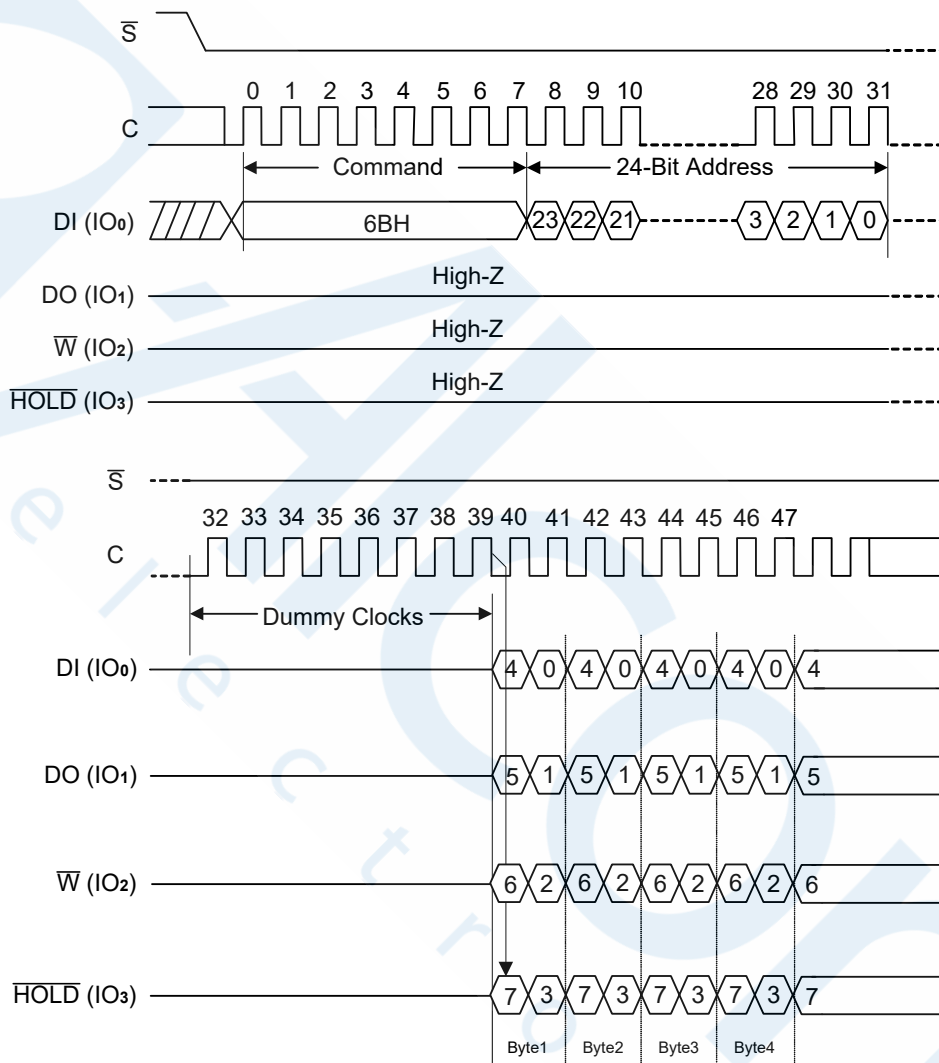


Quad Output Fast Read (6BH)

The Quad Output Fast Read command is followed by 3-Byte address (A23-A0) and a dummy Byte, each bit being latched in during the rising edge of C, then the memory contents are shifted out 4-bit per clock cycle from

IO₃, IO₂, IO₁ and IO₀. The command sequence is shown in followed Figure 10. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out.

Figure 10. Quad Output Fast Read Sequence Diagram



Dual I/O Fast Read (BBH)

The Dual I/O Fast Read command is similar to the Dual Output Fast Read command but with the capability to input the 3-Byte address (A23-0) and a “Continuous Read Mode” Byte 2-bit per clock by DI and DO, and each bit is latched in on the rising edge of C, then the memory contents are shifted out 2-bit per clock cycle from DI and DO. The command sequence is shown in followed Figure 11. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out.

Dual I/O Fast Read with “Continuous Read Mode”

The Dual I/O Fast Read command can further reduce command overhead through setting the “Continuous Read Mode” bits (M7-0) after the input 3-Byte address (A23-A0). If the “Continuous Read Mode” bits (M7-0) = AXH, then the next Dual I/O Fast Read command (after \overline{S} is raised and then lowered) does not require the BBH command code. The command sequence is shown in followed Figure 11. If the “Continuous Read Mode” bits (M7-0) are any value other than AXH, the next command requires the first BBH command code, thus returning to normal operation. A “Continuous Read Mode” Reset command can be used to reset (M7-0) before issuing normal command.

Figure 11. Dual I/O Fast Read Sequence Diagram (M7-0= 0XH or not AXH)

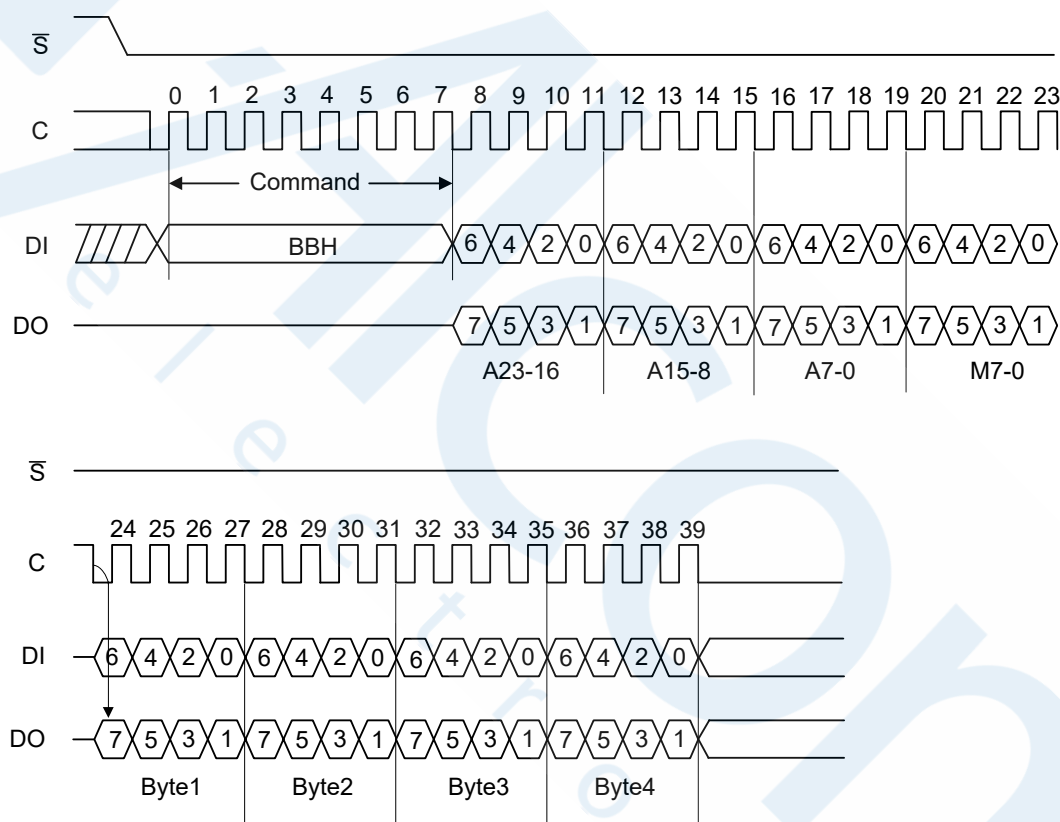
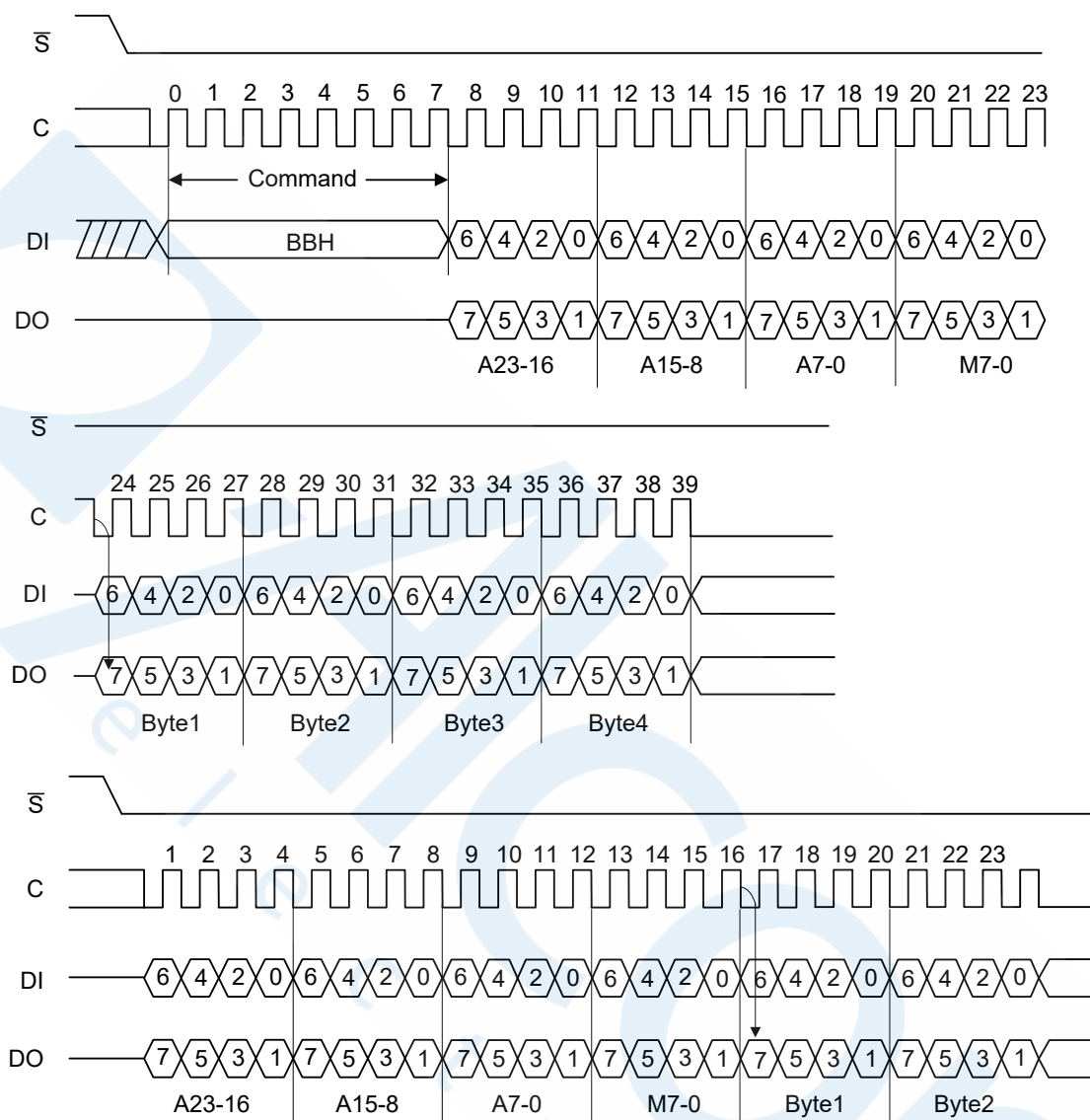


Figure 12. Dual I/O Fast Read Sequence Diagram (M7-0= AXH)


Quad I/O Fast Read (EBH)

The Quad I/O Fast Read command is similar to the Dual I/O Fast Read command but with the capability to input the 3-Byte address (A23-0) and a “Continuous Read Mode” Byte and 4-dummy clock 4-bit per clock by IO₀, IO₁, IO₂, IO₃, each bit being latched in during the rising edge of C, then the memory contents are shifted out 4-bit per clock cycle from IO₀, IO₁, IO₂, IO₃. The command sequence is shown in followed Figure 13. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out. The Quad Enable bit (QE) of Status Register (S9) must be set to enable for the Quad I/O Fast read command.

Quad I/O Fast Read with “Continuous Read Mode”

The Quad I/O Fast Read command can further reduce command overhead through setting the “Continuous Read Mode” bits (M7-0) after the input 3-Byte address (A23-A0). If the “Continuous Read Mode” bits (M7-0) = AXH, then the next Quad I/O Fast Read command (after \overline{S} is raised and then lowered) does not require the EBH command code. The command sequence is shown in followed Figure 14. If the “Continuous Read Mode” bits (M7-0) are any value other than AXH, the next command requires the first EBH command code, thus returning to normal operation. A “Continuous Read Mode” Reset command can be used to reset (M7-0) before issuing normal command.

Figure 13. Quad I/O Fast Read Sequence Diagram (M7-0= 0XH or not AXH)

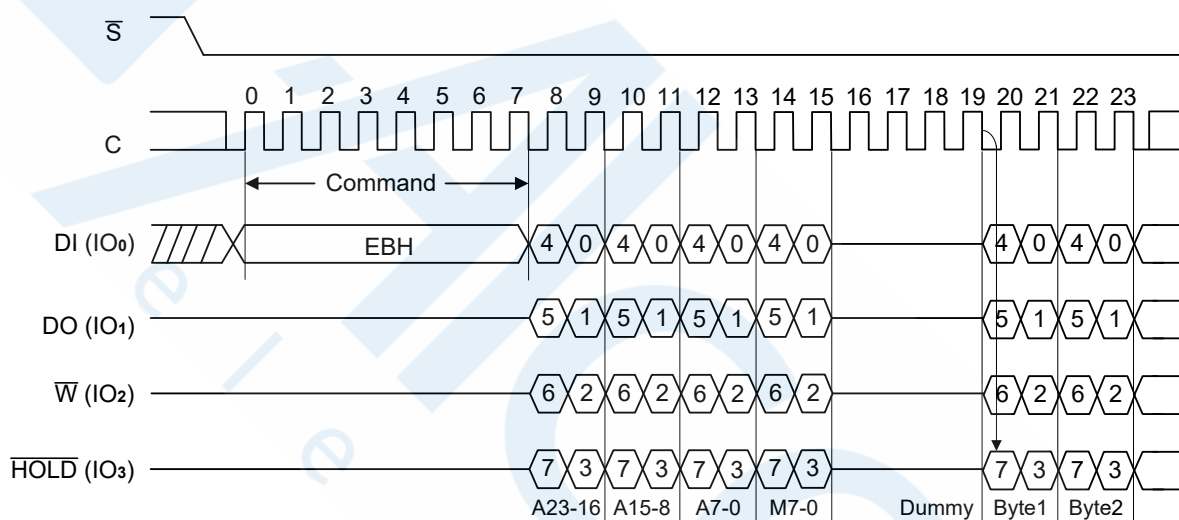
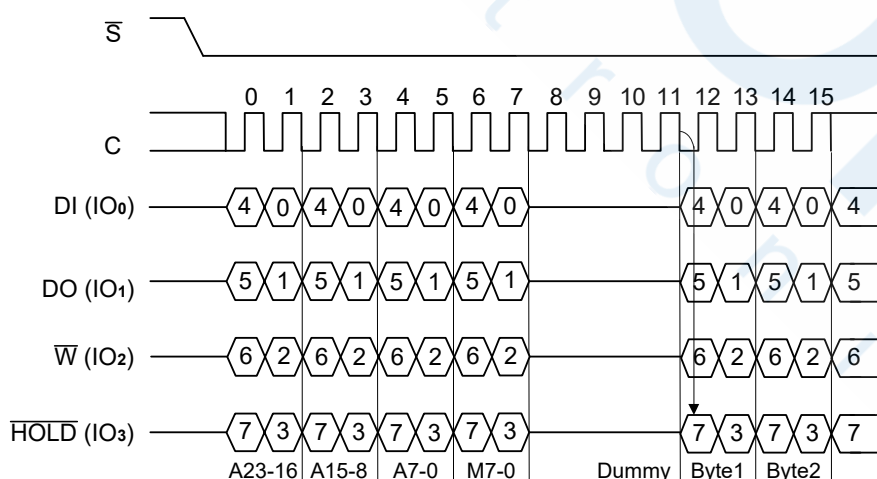


Figure 14. Quad I/O Fast Read Sequence Diagram (M7-0= AXH)



Quad I/O Word Fast Read (E7H)

The Quad I/O Word Fast Read command is similar to the Quad I/O Fast Read command except that the lowest address bit (A0) must be equal 0 and there are only 2-dummy clock. The command sequence is shown in followed Figure 15. The first Byte addressed can be at any location. The address is automatically incremented to the next higher address after each Byte of data is shifted out. The Quad Enable bit (QE) of Status Register (S9) must be set to enable for the Quad I/O Word Fast read command.

Quad I/O Word Fast Read with “Continuous Read Mode”

The Quad I/O Word Fast Read command can further reduce command overhead through setting the “Continuous Read Mode” bits (M7-0) after the input 3-Byte address (A23-A0). If the “Continuous Read Mode” bits (M7-0) = AXH, then the next Quad I/O Word Fast Read command (after \overline{S} is raised and then lowered) does not require the E7H command code. The command sequence is shown in followed Figure 16. If the “Continuous Read Mode” bits (M7-0) are any value other than AXH, the next command requires the first E7H command code, thus returning to normal operation. A “Continuous Read Mode” Reset command can be used to reset (M7-0) before issuing normal command.

Figure 15. Quad I/O Word Fast Read Sequence Diagram (M7-0= 0XH or not AXH)

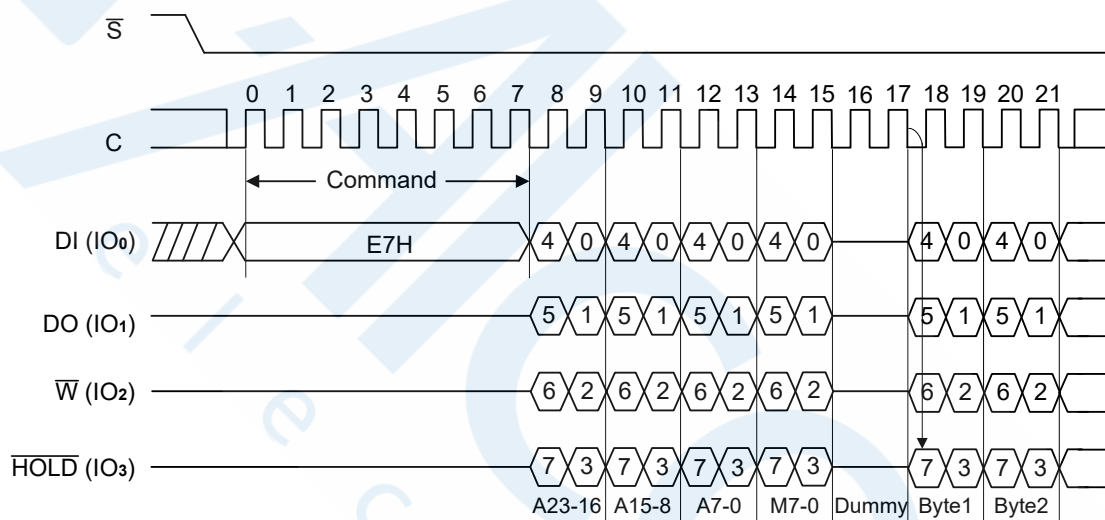
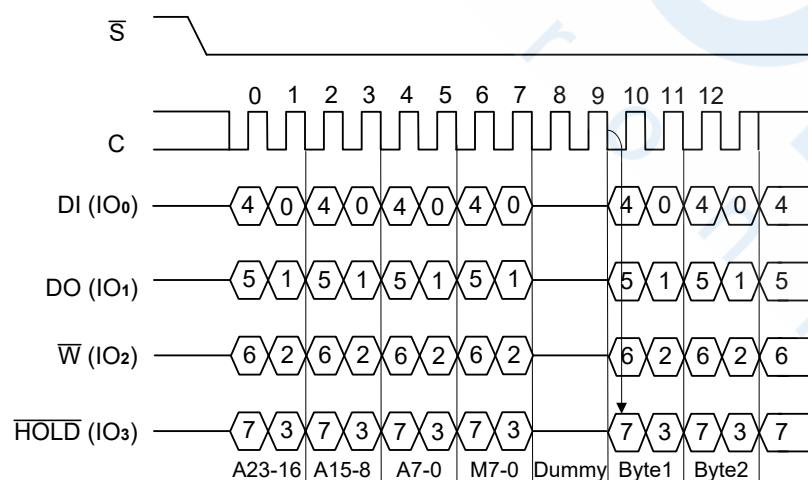


Figure 16. Quad I/O Word Fast Read Sequence Diagram (M7-0= AXH)



Set Burst with Wrap (77H)

The Set Burst with Wrap command is used in conjunction with “Quad I/O Fast Read” and “Quad I/O Word Fast Read” command to access a fixed length of 8/16/32/64-byte section within a 256-byte page.

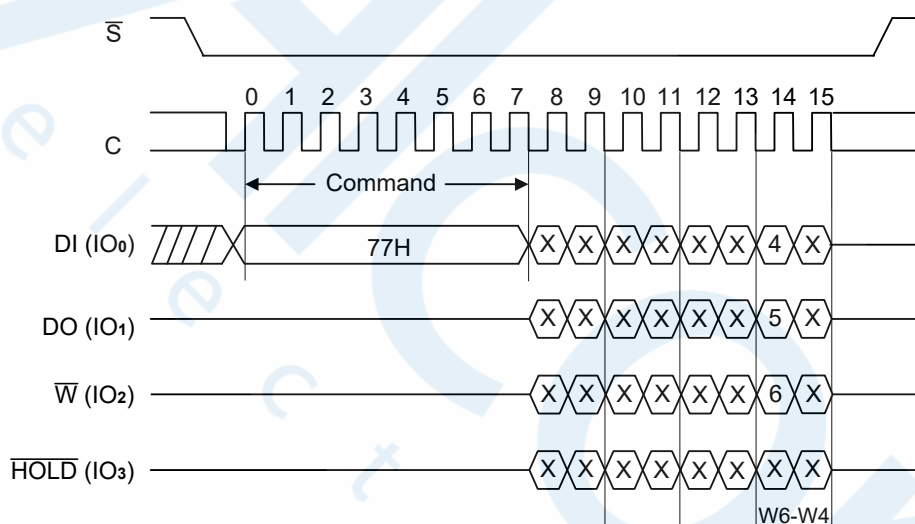
The Set Burst with Wrap command sequence: \overline{S} goes low → Send Set Burst with Wrap command → Send 24 dummy bits → Send 8 bits “Wrap bits” → \overline{S} goes high.

W6,W5	W4=0		W4=1 (default)	
	Wrap Around	Wrap Length	Wrap Around	Wrap Length
0,0	Yes	8-byte	No	N/A
0,1	Yes	16-byte	No	N/A
1,0	Yes	32-byte	No	N/A
1,1	Yes	64-byte	No	N/A

If the W6-W4 bits are set by the Set Burst with Wrap command, all the following “Quad I/O Fast Read” and “Quad I/O Word Fast Read” command will use the W6-W4 setting to access the 8/16/32/64-byte section within any

page. To exit the “Wrap Around” function and return to normal read operation, another Set Burst with Wrap command should be issued to set W4=1.

Figure 17. Set Burst with Wrap Sequence Diagram



Page Program (PP) (02H)

The Page Program (PP) command is for programming the memory. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Page Program command.

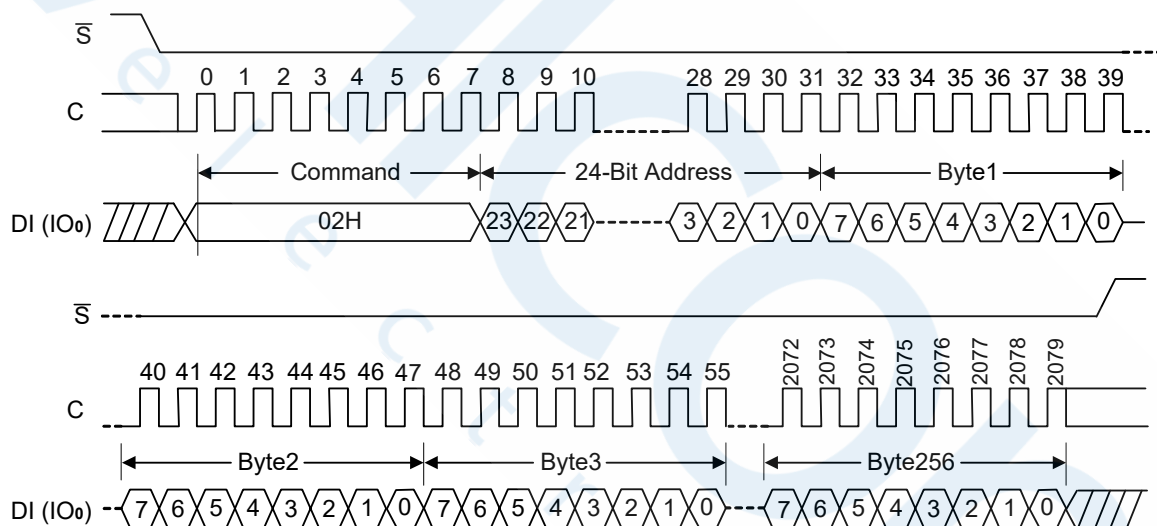
The Page Program (PP) command is entered by driving \overline{S} Low, followed by the command code, three address Bytes and at least one data Byte on DI. If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data that goes beyond the end of the current page are programmed from the start address of the same page (from the address whose 8 least significant bits (A7-A0) are all zero). \overline{S} must be driven low for the entire duration of the sequence. The Page Program command sequence: \overline{S} goes low → sending Page Program command → 3-Byte address on DI → at least 1 Byte data on DI → \overline{S} goes high. The command sequence is shown in Figure 18. If more than 256 Bytes are sent to the device, previously latched data are discarded and the last 256 data Bytes are

guaranteed to be programmed correctly within the same page. If less than 256 data Bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other Bytes of the same page. \overline{S} must be driven high after the eighth bit of the last data Byte has been latched in; otherwise the Page Program (PP) command is not executed.

As soon as \overline{S} is driven high, the self-timed Page Program cycle (whose duration is t_{PP}) is initiated. While the Page Program cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Page Program (PP) command applied to a page which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) is not executed.

Figure 18. Page Program Sequence Diagram



Dual Input Page Program (A2H)

The Dual Input Page Program command is for programming the memory using two pins: IO₀, IO₁. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Dual Input Page Program command. The quad Page Program command is entered by driving \bar{S} Low, followed by the command code (A2H), three address Bytes and at least one data Byte on IO pins.

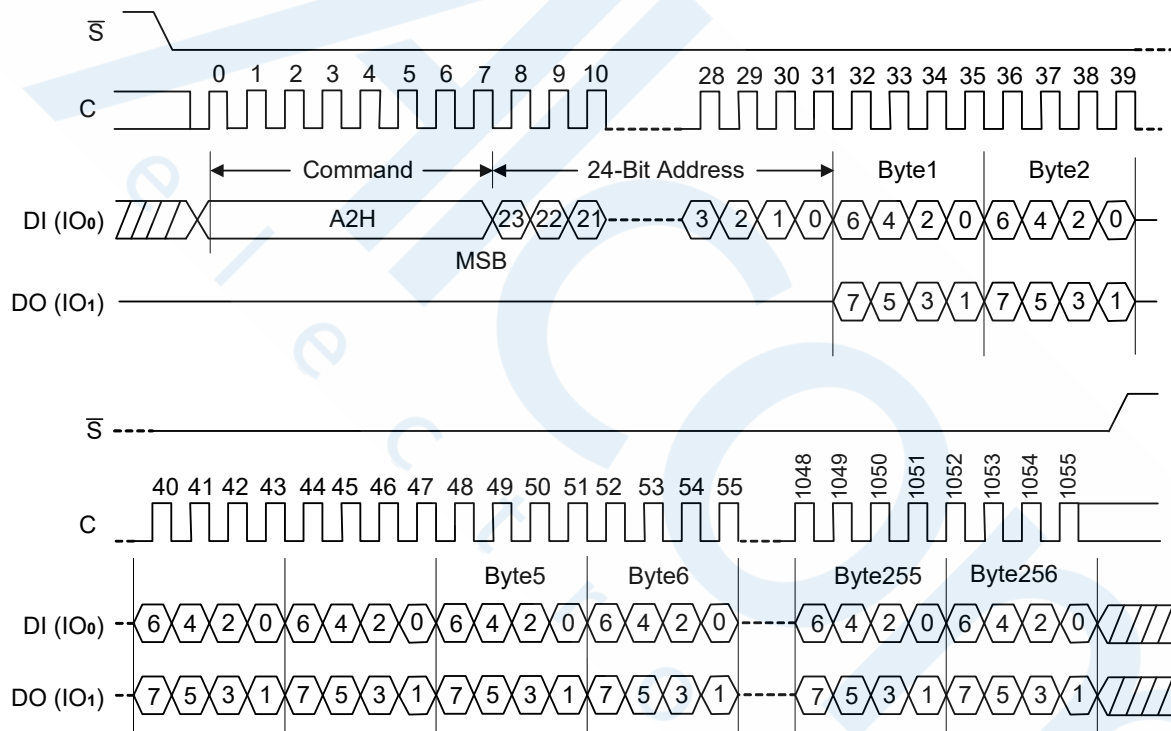
The command sequence is shown in Figure 19. If more than 256 Bytes are sent to the device, previously latched data are discarded and the last 256 data Bytes are guaranteed to be programmed correctly within the same page. If less than 256 data Bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other Bytes of the same page. \bar{S} must be driven high after the eighth bit of the last

data Byte has been latched in; otherwise the Dual Input Page Program command is not executed.

As soon as \bar{S} is driven high, the self-timed Dual Input Page Program cycle (whose duration is t_{PP}) is initiated. While the Dual Input Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Dual Input Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Dual Input Page Program command applied to a page which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) is not executed.

Figure 19. Dual input Page Program Sequence Diagram



Quad Page Program (32H)

The Quad Page Program command is for programming the memory using four pins: IO₀, IO₁, IO₂, and IO₃. To use Quad Page Program the Quad enable in status register Bit9 must be set (QE=1). A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Page Program command. The quad Page Program command is entered by driving \overline{S} Low, followed by the command code (32H), three address Bytes and at least one data Byte on IO pins.

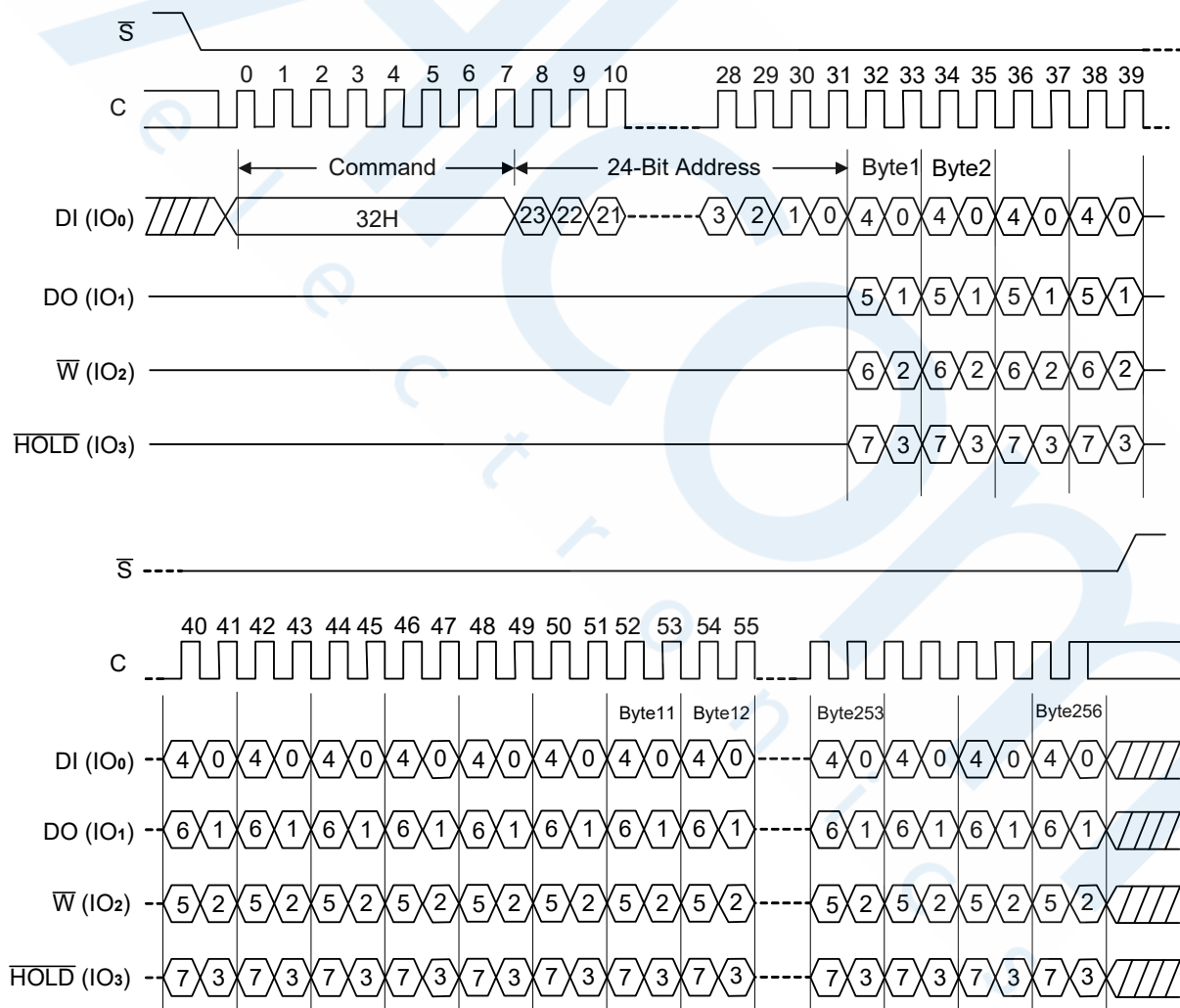
The command sequence is shown in Figure 20. If more than 256 Bytes are sent to the device, previously latched data are discarded and the last 256 data Bytes are guaranteed to be programmed correctly within the same page. If less than 256 data Bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other Bytes of the same page. \overline{S} must be driven high after the eighth bit of the last

data Byte has been latched in; otherwise the Quad Page Program (PP) command is not executed.

As soon as \overline{S} is driven high, the self-timed Quad Page Program cycle (whose duration is t_{PP}) is initiated. While the Quad Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Quad Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Quad Page Program command applied to a page which is protected by the Block Protect (BP₄, BP₃, BP₂, BP₁, and BP₀) is not executed.

Figure 20. Quad Page Program Sequence Diagram



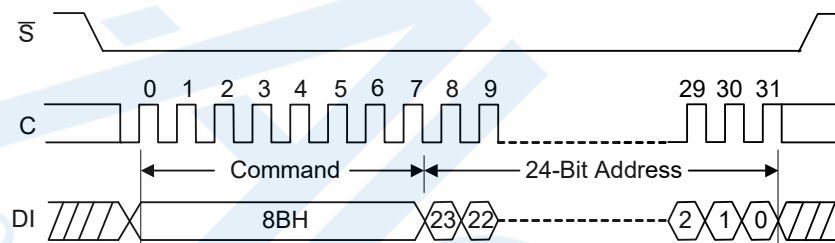
1KB Sector Erase (SE1K) (8BH)

The Sector Erase 1K(SE1K) command is used to erase all the data of the chosen sector. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The Sector Erase 1K(SE1K) command is entered by driving \bar{S} low, followed by the command code, and 3-address Byte on DI. Any address inside the sector is a valid address for the Sector Erase 1K (SE1K) command. \bar{S} must be driven low for the entire duration of the sequence.

The Sector Erase command sequence: \bar{S} goes low → sending Sector Erase command → 3-Byte address on DI → \bar{S} goes high. The command sequence is shown in Figure 21. \bar{S} must be driven high after the eighth bit of

the last address Byte has been latched in; otherwise the Sector Erase 1K (SE1K) command is not executed. As soon as \bar{S} is driven high, the self-timed Sector Erase cycle (whose duration is t_{SE}) is initiated. While the Sector Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Sector Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A Sector Erase 1K (SE1K) command applied to a sector which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) bit (see Table1 & 1a) is not executed.

Figure 21. Sector Erase 1K Sequence Diagram



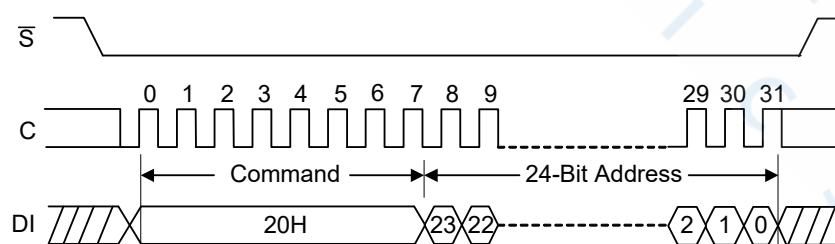
Sector Erase (SE) (20H)

The Sector Erase (SE) command is used to erase all the data of the chosen sector. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The Sector Erase (SE) command is entered by driving \bar{S} low, followed by the command code, and 3-address Byte on DI. Any address inside the sector is a valid address for the Sector Erase (SE) command. \bar{S} must be driven low for the entire duration of the sequence.

The Sector Erase command sequence: \bar{S} goes low → sending Sector Erase command → 3-Byte address on DI → \bar{S} goes high. The command sequence is shown in Figure 22. \bar{S} must be driven high after the eighth bit of the

last address Byte has been latched in; otherwise the Sector Erase (SE) command is not executed. As soon as \bar{S} is driven high, the self-timed Sector Erase cycle (whose duration is t_{SE}) is initiated. While the Sector Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Sector Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A Sector Erase (SE) command applied to a sector which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) bit (see Table1 & 1a) is not executed.

Figure 22. Sector Erase Sequence Diagram



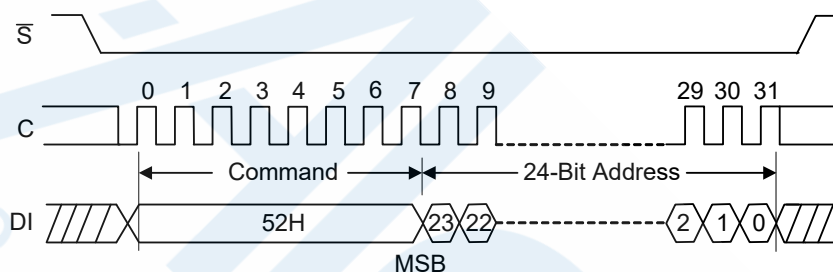
32KB Block Erase (BE32) (52H)

The 32KB Block Erase (BE32) command is used to erase all the data of the chosen block. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The 32KB Block Erase (BE32) command is entered by driving \bar{S} low, followed by the command code, and three address Bytes on DI. Any address inside the block is a valid address for the 32KB Block Erase (BE32) command. \bar{S} must be driven low for the entire duration of the sequence.

The 32KB Block Erase command sequence: \bar{S} goes low → sending 32KB Block Erase command → 3-Byte address on DI → \bar{S} goes high. The command sequence is shown in Figure 23. \bar{S} must be driven high after the

eighth bit of the last address Byte has been latched in; otherwise the 32KB Block Erase (BE32) command is not executed. As soon as \bar{S} is driven high, the self-timed Block Erase cycle (whose duration is t_{BE1}) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A 32KB Block Erase (BE32) command applied to a block which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) bits (see Table1 & 1a) is not executed.

Figure 23. 32KB Block Erase Sequence Diagram



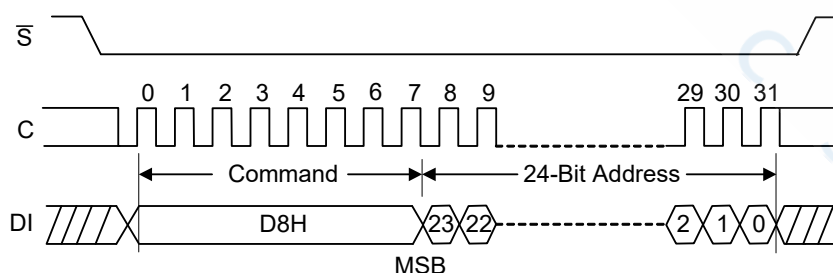
64KB Block Erase (BE64) (D8H)

The 64KB Block Erase (BE64) command is used to erase all the data of the chosen block. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The 64KB Block Erase (BE64) command is entered by driving \bar{S} low, followed by the command code, and three address Bytes on DI. Any address inside the block is a valid address for the 64KB Block Erase (BE64) command. \bar{S} must be driven low for the entire duration of the sequence.

The 64KB Block Erase command sequence: \bar{S} goes low → sending 64KB Block Erase command → 3-Byte address on DI → \bar{S} goes high. The command sequence is shown in Figure 24. \bar{S} must be driven high after the

eighth bit of the last address Byte has been latched in; otherwise the 64KB Block Erase (BE64) command is not executed. As soon as \bar{S} is driven high, the self-timed Block Erase cycle (whose duration is t_{BE2}) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A 64KB Block Erase (BE64) command applied to a block which is protected by the Block Protect (BP4, BP3, BP2, BP1, and BP0) bits (see Table1 & 1a) is not executed.

Figure 24. 64KB Block Erase Sequence Diagram



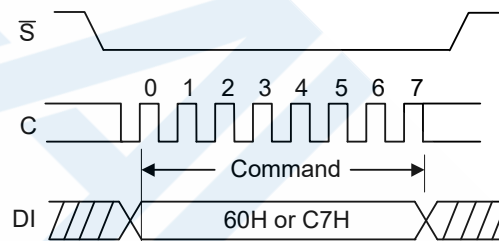
Chip Erase (CE) (60/C7H)

The Chip Erase (CE) command is used to erase all the data of the chip. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The Chip Erase (CE) command is entered by driving \overline{S} Low, followed by the command code on Serial Data Input (DI). \overline{S} must be driven Low for the entire duration of the sequence.

The Chip Erase command sequence: \overline{S} goes low → sending Chip Erase command → \overline{S} goes high. The command sequence is shown in Figure 25. \overline{S} must be driven high after the eighth bit of the command code has been latched in; otherwise the Chip Erase command is not

executed. As soon as \overline{S} is driven high, the self-timed Chip Erase cycle (whose duration is t_{CE}) is initiated. While the Chip Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Chip Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. The Chip Erase (CE) command is executed if the Block Protect (BP2, BP1, and BP0) bits are 0 and CMP=0 or the Block Protect (BP2, BP1, and BP0) bits are 1 and CMP=1. The Chip Erase (CE) command is ignored if one or more sectors are protected.

Figure 25. Chip Erase Sequence Diagram



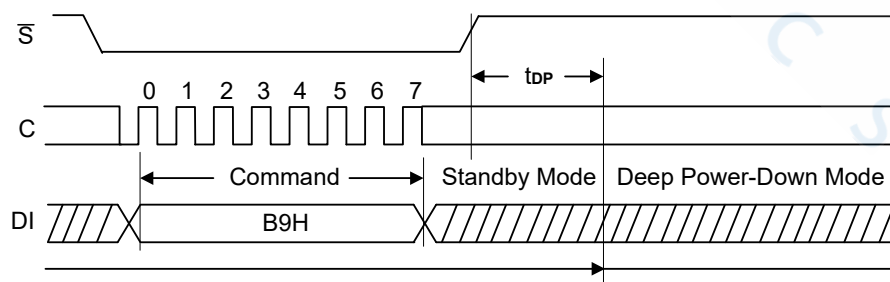
Deep Power-Down (DP) (B9H)

Executing the Deep Power-Down (DP) command is the only way to put the device in the lowest consumption mode (the Deep Power-Down Mode). It can also be used as an extra software protection mechanism, while the device is not in active use, since in this mode, the device ignores all Write, Program and Erase commands. Driving \overline{S} high deselects the device, and puts the device in the Standby Mode (if there is no internal cycle currently in progress). But this mode is not the Deep Power-Down Mode. The Deep Power-Down Mode can only be entered by executing the Deep Power-Down (DP) command. Once the device has entered the Deep Power-Down Mode, all commands are ignored except the Release from Deep Power-Down and Read Device ID (RDI) command. These commands can release the device from this mode. The Release from Deep Power-Down and Read Device ID (RDI) command releases the device from deep power down mode, also

allows the Device ID of the device to be output on DO. The Deep Power-Down Mode automatically stops at Power-Down, and the device is in the Standby Mode after Power-Up.

The Deep Power-Down command sequence: \overline{S} goes low → sending Deep Power-Down command → \overline{S} goes high. The command sequence is shown in Figure 26. \overline{S} must be driven high after the eighth bit of the command code has been latched in; otherwise the Deep Power-Down (DP) command is not executed. As soon as \overline{S} is driven high, it requires a delay of t_{DP} before the supply current is reduced to I_{CC2} and the Deep Power-Down Mode is entered. Any Deep Power-Down (DP) command, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

Figure 26. Deep Power-Down Sequence Diagram



Release from Deep Power-Down or High Performance Mode and Read Device ID (RDI) (ABH)

The Release from Power-Down or High Performance Mode / Device ID command is a multi-purpose command. It can be used to release the device from the Power-Down state or High Performance Mode or obtain the device's electronic identification (ID) number.

To release the device from the Power-Down state or High Performance Mode, the command is issued by driving the \overline{S} pin low, shifting the instruction code "ABH" and driving \overline{S} high as shown in Figure 27. Release from Power-Down will take the time duration of t_{RES1} (See AC Characteristics) before the device will resume normal operation and other commands are accepted. The \overline{S} pin must remain high during the t_{RES1} time duration.

When used only to obtain the Device ID while not in the Power-Down state, the command is initiated by driving the \overline{S} pin low and shifting the instruction code "ABH" followed by 3-dummy Bytes. The Device ID bits are then shifted out

on the falling edge of C with most significant bit (MSB) first as shown in Figure 28. The Device ID value is listed in Manufacturer and Device Identification table. The Device ID can be read continuously. The command is completed by driving \overline{S} high.

When used to release the device from the Power-Down state and obtain the Device ID, the command is the same as previously described, and shown in Figure 28, except that after \overline{S} is driven high it must remain high for a time duration of t_{RES2} (See AC Characteristics). After this time duration the device will resume normal operation and other commands will be accepted. If the Release from Power-Down / Device ID command is issued while an Erase, Program or Write cycle is in process (when WIP equal 1) the command is ignored and will not have any effects on the current cycle.

Figure 27. Release Power-Down Sequence or High Performance Mode Sequence Diagram

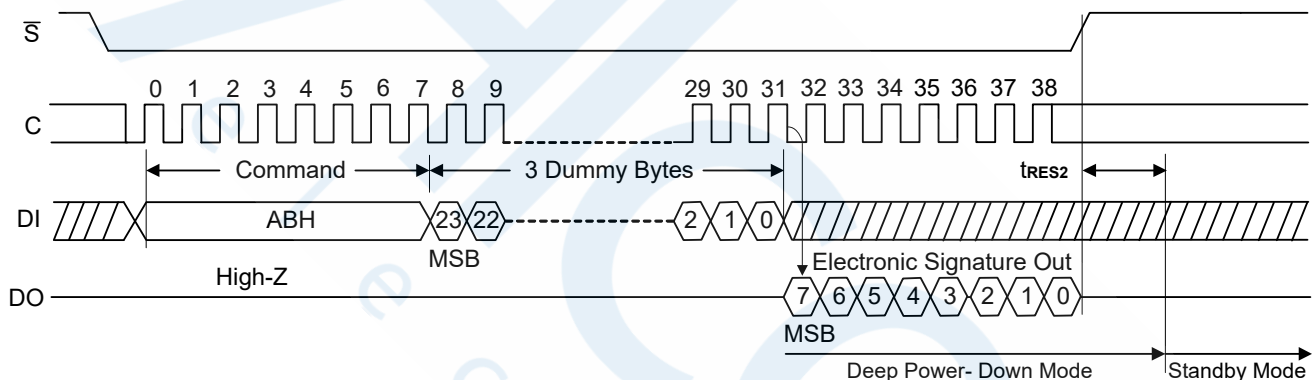
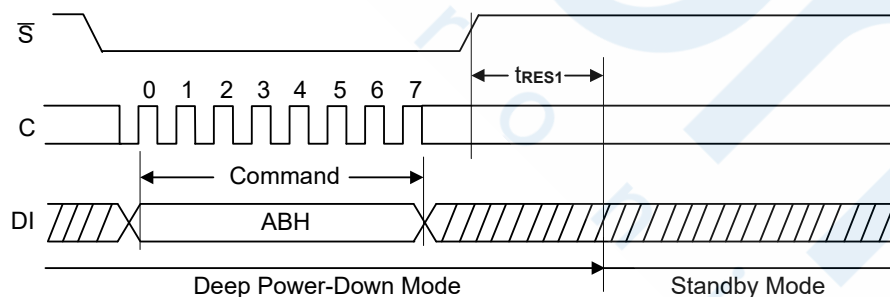


Figure 28. Release Power-Down/Read Device ID Sequence Diagram



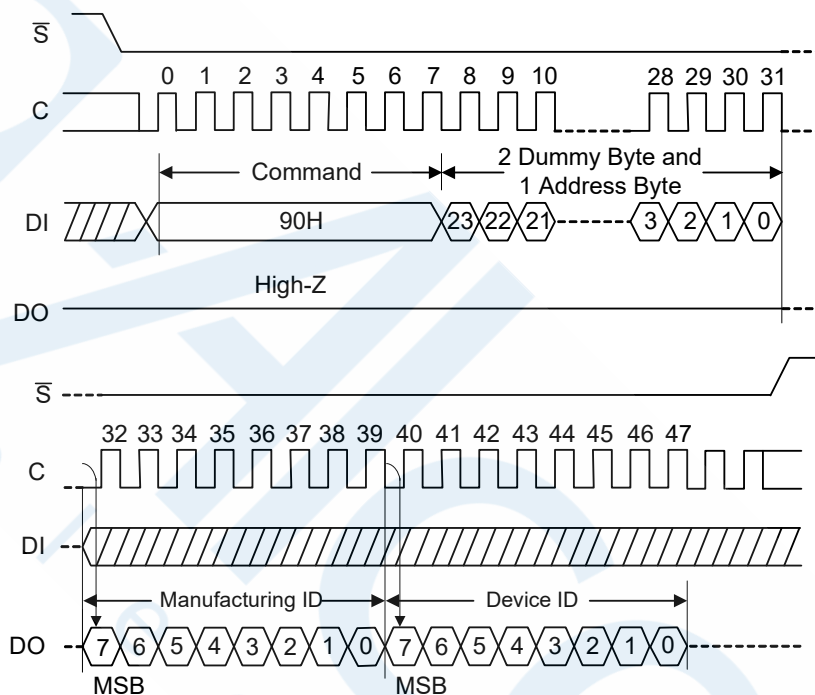
Read Manufacture ID/ Device ID (REMS) (90H)

The Read Manufacturer/Device ID command is an alternative to the Release from Power-Down / Device ID command that provides both the JEDEC assigned Manufacturer ID and the specific Device ID.

The command is initiated by driving the \bar{S} pin low and shifting the command code "90H" followed by a 24-bit

address (A23-A0) of 000000H. After which, the Manufacturer ID and the Device ID are shifted out on the falling edge of C with most significant bit (MSB) first as shown in Figure 29. If the 24-bit address is initially set to 000001H, the Device ID will be read first.

Figure 29. Read Manufacture ID/ Device ID Sequence Diagram



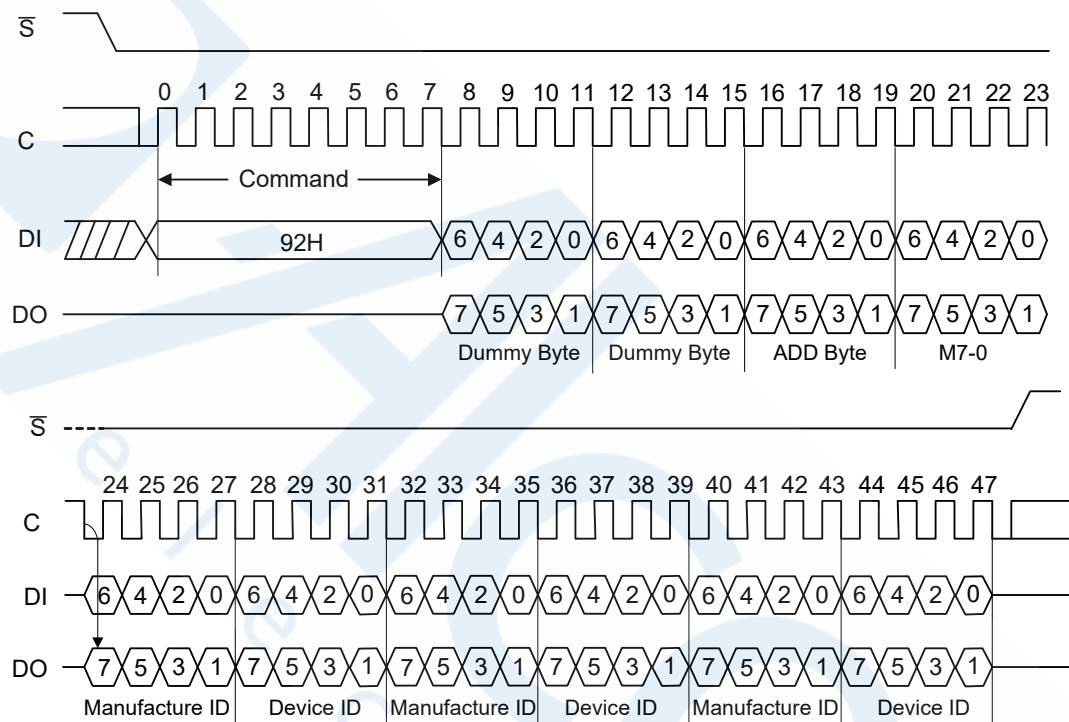
Dual I/O Read Electronic Manufacturer ID/ Device ID (92H)

The Dual I/O Read Manufacturer/Device ID command is an alternative to the Release from Power-Down / Device ID command that provides both the JEDEC assigned Manufacturer ID and the specific Device ID by dual I/O.

The command is initiated by driving the \bar{S} pin low and shifting the command code "92H" followed by a 24-bit

address (A23-A0) of 000000H. After which, the Manufacturer ID and the Device ID are shifted out on the falling edge of C with most significant bit (MSB) first as shown in Figure 30. If the 24-bit address is initially set to 000001H, the Device ID will be read first.

Figure 30. Dual I/O Read Manufacture ID/ Device ID Sequence Diagram



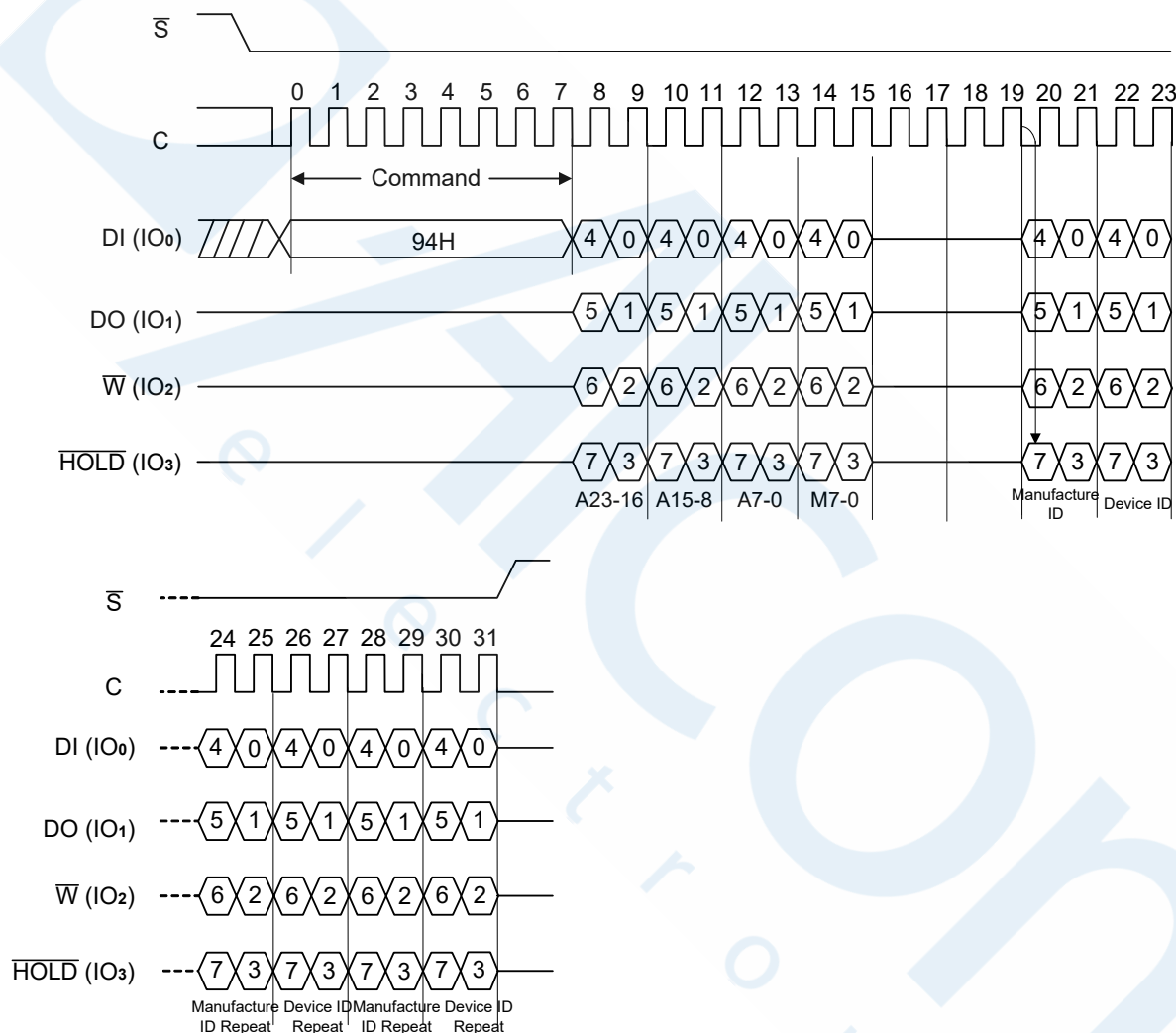
Quad I/O Read Electronic Manufacturer ID/ Device ID (94H)

The Quad I/O Read Manufacturer/Device ID command is an alternative to the Release from Power-Down / Device ID command that provides both the JEDEC assigned Manufacturer ID and the specific Device ID by quad I/O.

The command is initiated by driving the \overline{S} pin low and shifting the command code "94H" followed by a 24-bit

address (A23-A0) of 000000H, and 4 dummy clocks. After which, the Manufacturer ID and the Device ID are shifted out on the falling edge of C with most significant bit (MSB) first as shown in Figure 31. If the 24-bit address is initially set to 000001H, the Device ID will be read first.

Figure 31. Quad I/O Read Manufacture ID/ Device ID Sequence Diagram

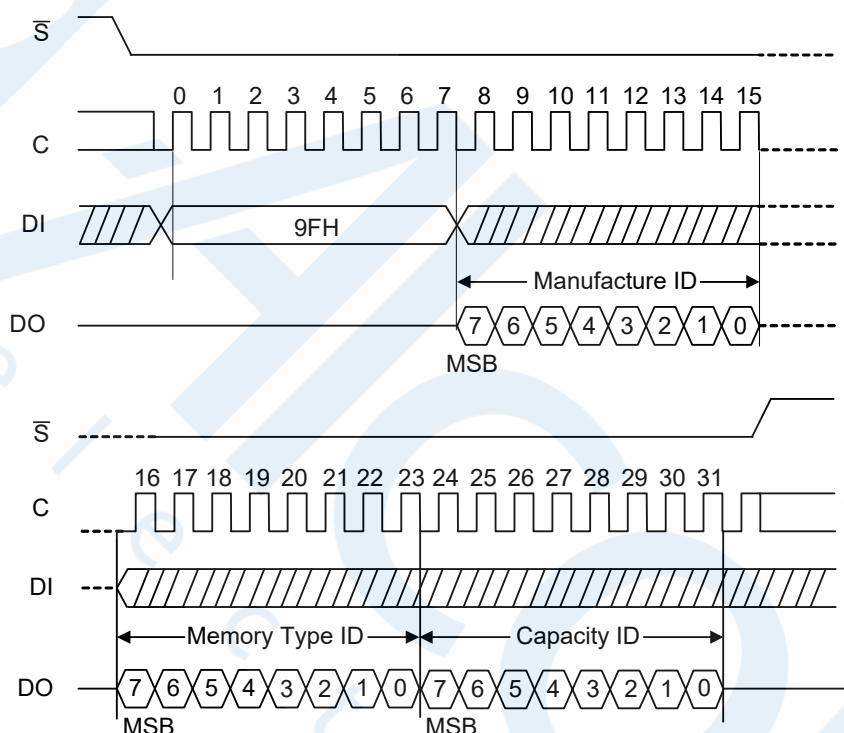


Read Identification (RDID) (9FH)

The Read Identification (RDID) command allows the 8-bit manufacturer identification to be read, followed by two Bytes of device identification. The device identification indicates the memory type in the first Byte, and the memory capacity of the device in the second Byte. The Read Identification (RDID) command while an Erase or Program cycle is in progress is not decoded, and has no effect on the cycle that is in progress. The Read Identification (RDID) command should not be issued while the device is in Deep Power-Down Mode.

The device is first selected by driving \overline{S} low. Then, the 8-bit command code for the command is shifted in. This is followed by the 24-bit device identification, stored in the memory, each bit is shifted out on the falling edge of Serial Clock. The command sequence is shown in Figure 32. The Read Identification (RDID) command is terminated by driving \overline{S} high at any time during data output. When \overline{S} is driven high, the device is in the Standby Mode. Once in the Standby Mode, the device waits to be selected, so that it can receive, decode and execute commands.

Figure 32. Read Identification ID Sequence Diagram

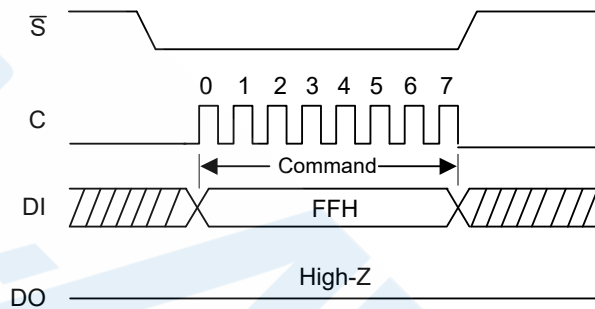


Continuous Read Mode Reset (CRMR) (FFH)

The Dual/Quad I/O Fast Read operations, “Continuous Read Mode” bits (M7-0) are implemented to further reduce command overhead. By setting the (M7-0) to AXH, the next Dual/Quad I/O Fast Read operations do not require the BBH/EBH/E7H command code. Because the A25LQ080A has no hardware reset pin, so if

Continuous Read Mode bits are set to “AXH”, the A25LQ080A will not recognize any standard SPI commands. So Continuous Read Mode Reset command will release the Continuous Read Mode from the “AXH” state and allow standard SPI command to be recognized. The command sequence is show in Figure 33.

Figure 33. Continuous Read Mode Reset Sequence Diagram

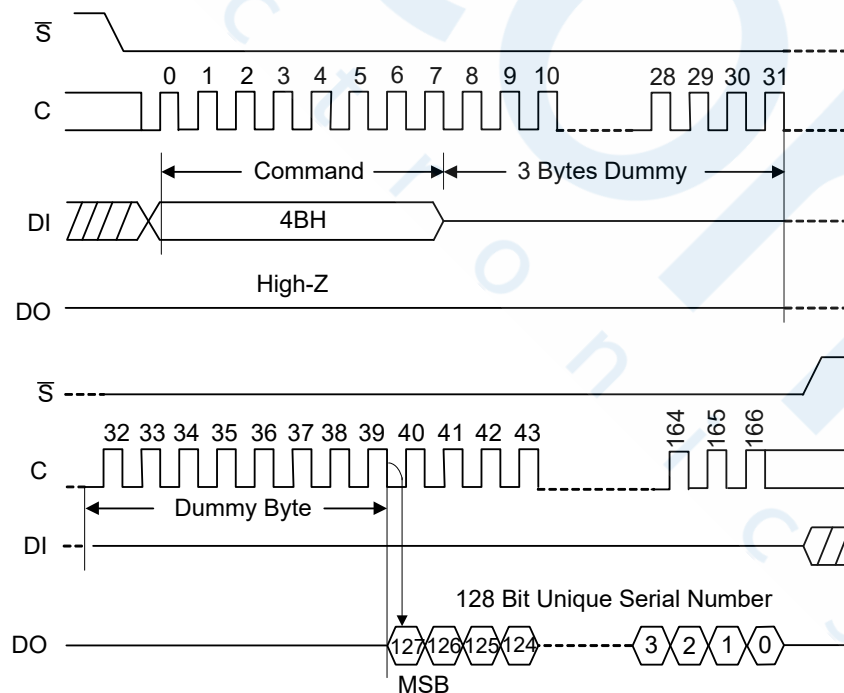


Read Unique ID (4BH)

The Read Unique ID command accesses a factory-set read-only 128bit number that is unique to each A25LQ080A device. The Unique ID can be used in conjunction with user software methods to help prevent copying or cloning of a system. The Read Unique ID command sequence: \overline{CS}

goes low → sending Read Unique ID command → Dummy Byte1 → Dummy Byte2 → Dummy Byte3 → Dummy Byte4 → 128bit Unique ID Out → \overline{CS} goes high. The command sequence is show below.

Figure 34. Read Unique ID Sequence Diagram



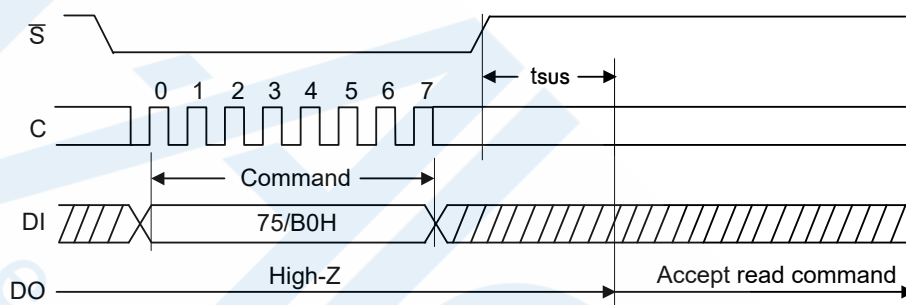
Program/Erase Suspend (PES) (75/B0H)

The Program/Erase Suspend command “75/B0H”, allows the system to interrupt a page program or sector/block erase operation and then read data from any other sector or block. The Write Status Register command (01H) and Erase/Program Security Registers command (44H,42H) and Erase commands (8BH, 20H, 52H, D8H, C7H, 60H) and Page Program command (02H / 32H) are not allowed during Program suspend. The Write Status Register command (01H) and Erase Security Registers command (44H) and Erase commands (8BH, 20H, 52H, D8H, C7H, 60H) are not allowed during Erase suspend. Program/Erase Suspend is valid only during the page program or sector/block erase operation. A maximum of

time of “tsus” (See AC Characteristics) is required to suspend the program/erase operation.

The Program/Erase Suspend command will be accepted by the device only if the SUS2/SUS1 bit in the Status Register equal to 0 and WIP bit equal to 1 while a Page Program or a Sector or Block Erase operation is on-going. If the SUS2/SUS1 bit equal to 1 or WIP bit equal to 0, the Suspend command will be ignored by the device. The WIP bit will be cleared from 1 to 0 within “tsus” and the SUS2/SUS1 bit will be set from 0 to 1 immediately after Program/Erase Suspend. A power-off during the suspend period will reset the device and release the suspend state. The command sequence is show in Figure 35.

Figure 35. Program/Erase Suspend Sequence Diagram

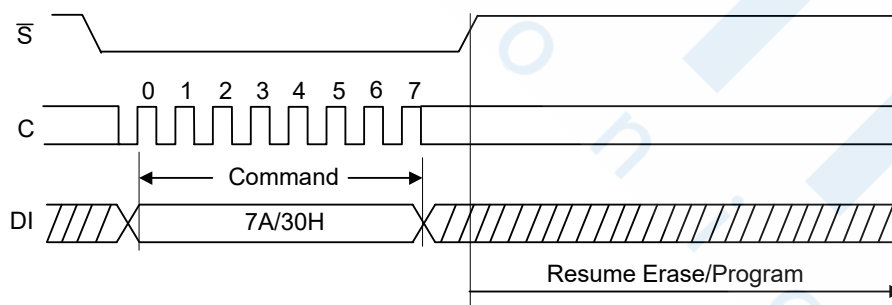


Program/Erase Resume (PER) (7A/30H)

The Program/Erase Resume command must be written to resume the program or sector/block erase operation after a Program/Erase Suspend command. The Program/Erase Resume command will be accepted by the device only if the SUS2/SUS1 bit equal to 1 and the WIP bit equal to 0. After issued the SUS2/ SUS1 bit in the status register will

be cleared from 1 to 0 immediately, the WIP bit will be set from 0 to 1 within 200ns and the Sector or Block will complete the erase operation or the page will complete the program operation. The Program/Erase Resume command will be ignored unless a Program/Erase Suspend is active. The command sequence is show in Figure 36.

Figure 36. Program/Erase Resume Sequence Diagram



Erase Security Registers (44H)

The A25LQ080A provides three 1024-Byte Security Registers which can be read and programmed individually. These registers may be used by the system manufacturers to store security and other important information separately from the main memory array.

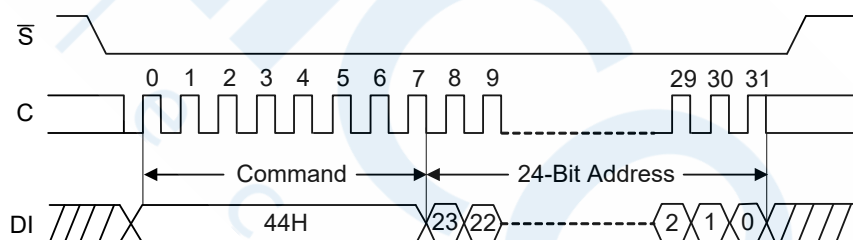
The Erase Security Registers command is similar to Sector/Block Erase command. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit.

The Erase Security Registers command sequence: \bar{S} goes low → sending Erase Security Registers command → 3-Byte address on DI → \bar{S} goes high. The command sequence is shown in Figure 37. \bar{S} must be driven high after the eighth bit of the last byte of address has been latched in, otherwise the Erase Security Registers

command is not executed. As soon as \bar{S} is driven high, the self-timed Erase Security Registers cycle (whose duration is t_{SE}) is initiated. While the Erase Security Registers cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Erase Security Registers cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. The Security Registers Lock Bit (LB3-1) in the Status Register can be used to OTP protect the security registers. Once the LB3-1 bits is set to 1, the Security Registers will be permanently locked; the Erase Security Registers command will be ignored.

Address	A23-A16	A15-A12	A11-A10	A9-A0
Security Registers #1	00H	0001	0	Byte Address
Security Registers #2	00H	0010	0	Byte Address
Security Registers #3	00H	0011	0	Byte Address

Figure 37. Erase Security Registers Command Sequence Diagram

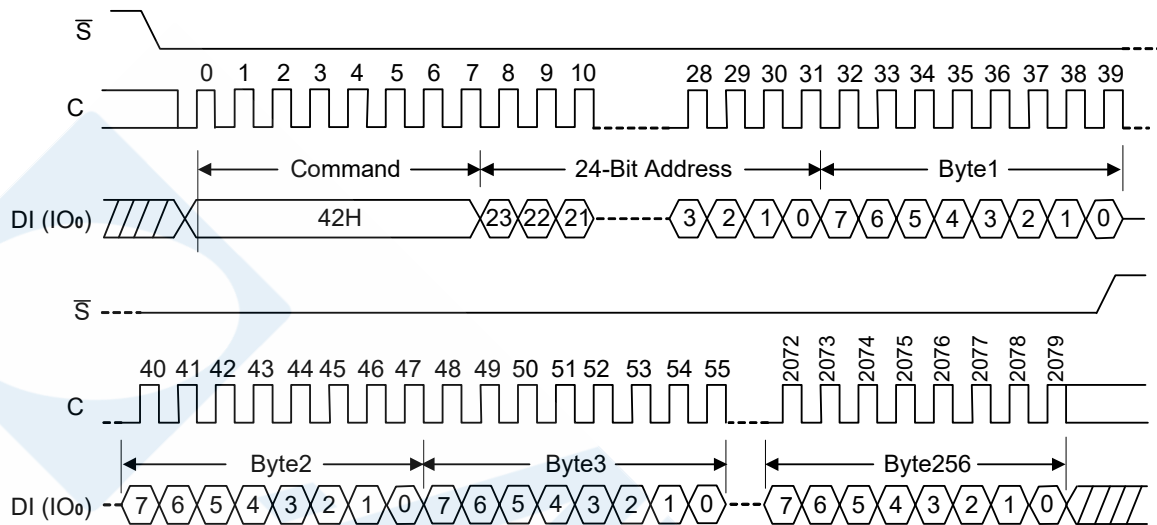


Program Security Registers (42H)

The Program Security Registers command is similar to the Page Program command. Each security register contains four pages content. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Program Security Registers command. The Program Security Registers command is entered by driving \bar{S} Low, followed by the command code (42H), three address Bytes and at least one data Byte on DI. As soon as \bar{S} is driven high, the self-timed Program Security Registers cycle

(whose duration is t_{PP}) is initiated. While the Program Security Registers cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Program Security Registers cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. If the Security Registers Lock Bit (LB3-1) is set to 1, the Security Registers will be permanently locked. Program Security Registers command will be ignored.

Address	A23-A16	A15-A12	A11-A10	A9-A0
Security Registers #1	00H	0001	0	Byte Address
Security Registers #2	00H	0010	0	Byte Address
Security Registers #3	00H	0011	0	Byte Address

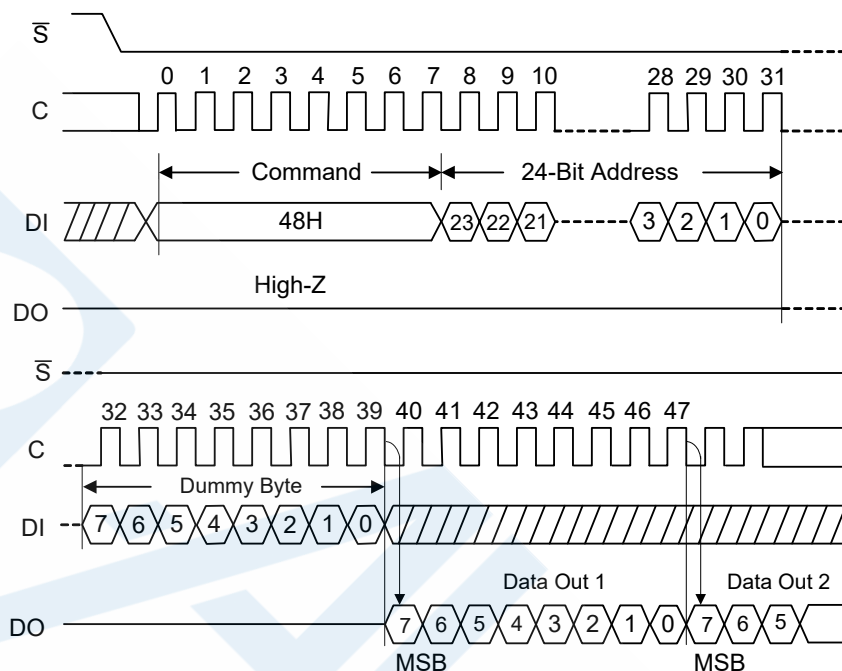
Figure 38. Program Security Registers Command Sequence Diagram


Read Security Registers (48H)

The Read Security Registers command is similar to Fast Read command. The command is followed by a 3-Byte address (A23-A0) and a dummy Byte, and each bit is latched-in on the rising edge of C. Then the memory content, at that address, is shifted out on DO, and each bit is shifted out, at a Max frequency f_c , on the falling edge of C. The first Byte addressed can be at any location. The

address is automatically incremented to the next higher address after each Byte of data is shifted out. Once the A9-A0 address reaches the last Byte of the register (Byte 3FFH), it will reset to 000H, the command is completed by driving \bar{S} high.

Address	A23-A16	A15-A12	A11-A10	A9-A0
Security Registers #1	00H	0001	0	Byte Address
Security Registers #2	00H	0010	0	Byte Address
Security Registers #3	00H	0011	0	Byte Address

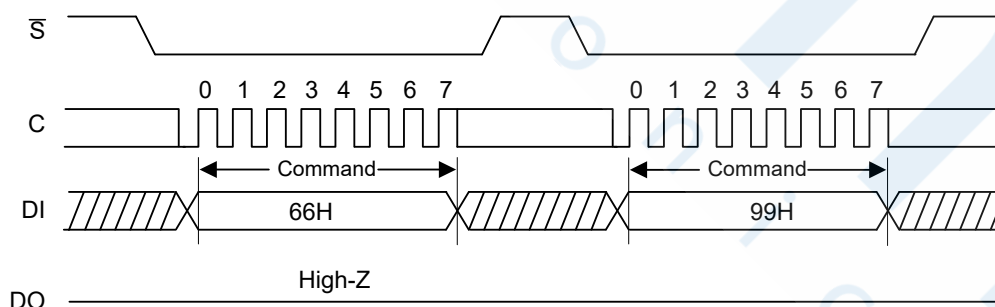
Figure 39. Read Security Registers Command Sequence Diagram


Enable Reset (66H) and Reset (99H)

If the Reset command is accepted, any on-going internal operation will be terminated and the device will return to its default power-on state and lose all the current volatile settings, such as Volatile Status Register bits, Write Enable Latch status (WEL), Program/Erase Suspend status, Read Parameter setting (P7-P0), Continuous Read Mode bit setting (M7-M0) and Wrap Bit Setting (W6-W4).

The "Reset (99H)" command sequence as follow: \bar{S} goes low → Sending Enable Reset command → \bar{S} goes high → \bar{S} goes low → Sending Reset command

→ \bar{S} goes high. Once the Reset command is accepted by the device, the device will take approximately $t_{RST} = 30\mu s / 120\mu s / 4ms$ to reset. During this period, no command will be accepted. Data corruption may happen if there is an on-going or suspended internal Erase or Program operation when Reset command sequence is accepted by the device. It is recommended to check the BUSY bit and the SUS bit in Status Register before issuing the Reset command sequence.

Figure 40. Enable Reset and Reset Command Sequence Diagram


Read Serial Flash Discoverable Parameter (5AH)

The Serial Flash Discoverable Parameter (SFDP) standard provides a consistent method of describing the functional and feature capabilities of serial flash devices in a standard set of internal parameter tables. These parameter tables can be interrogated by host system software to enable

adjustments needed to accommodate divergent features from multiple vendors. The concept is similar to the one found in the Introduction of JEDEC Standard, JESD68 on CFI. SFDP is a standard of JEDEC Standard No.216.

Figure 41. Read Serial Flash Discoverable Parameter Command Sequence Diagram

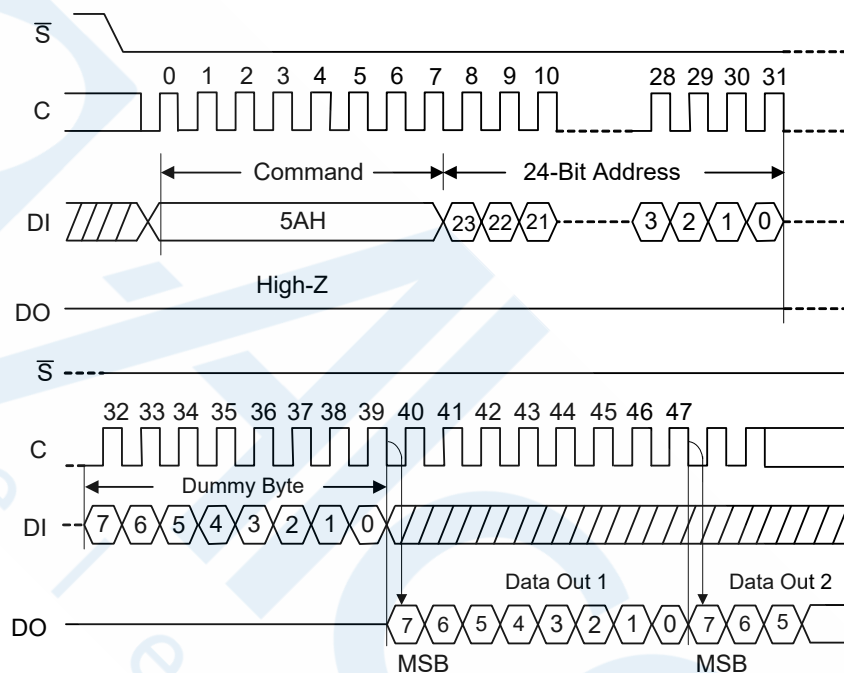


Table 3. Signature and Parameter Identification Data Values

Description	Comment	Add(H) (Byte)	DW Add (Bit)	Data	Data
SFDP Signature	Fixed:50444653H	00H	07:00	53H	53H
		01H	15:08	46H	46H
		02H	23:16	44H	44H
		03H	31:24	50H	50H
SFDP Minor Revision Number	Start from 00H	04H	07:00	06H	06H
SFDP Major Revision Number	Start from 01H	05H	15:08	01H	01H
Number of Parameters Headers	Start from 00H	06H	23:16	01H	01H
Unused	Contains 0xFFH and can never be changed	07H	31:24	FFH	FFH
ID number (JEDEC)	00H: It indicates a JEDEC specified header	08H	07:00	00H	00H
Parameter Table Minor Revision Number	Start from 0x00H	09H	15:08	06H	06H
Parameter Table Major Revision Number	Start from 0x01H	0AH	23:16	01H	01H
Parameter Table Length (in double word)	How many DWORDs in the Parameter table	0BH	31:24	09H	09H
Parameter Table Pointer (PTP)	First address of JEDEC Flash Parameter table	0CH	07:00	30H	30H
		0DH	15:08	00H	00H
		0EH	23:16	00H	00H
Unused	Contains 0xFFH and can never be changed	0FH	31:24	FFH	FFH
ID Number (AMIC Device Manufacturer ID)	It indicates AMIC Device manufacturer ID	10H	07:00	37H	37H
Parameter Table Minor Revision Number	Start from 0x00H	11H	15:08	00H	00H
Parameter Table Major Revision Number	Start from 0x01H	12H	23:16	01H	01H
Parameter Table Length (in double word)	How many DWORDs in the Parameter table	13H	31:24	03H	03H
Parameter Table Pointer (PTP)	First address of AMIC Device Flash Parameter table	14H	07:00	60H	60H
		15H	15:08	00H	00H
		16H	23:16	00H	00H
Unused	Contains 0xFFH and can never be changed	17H	31:24	FFH	FFH

Table 4. Parameter Table (0): JEDEC Flash Parameter Tables

Description	Comment	Add(H) (Byte)	DW Add (Bit)	Data	Data
Block/Sector Erase Size	00: Reserved; 01: 4KB erase; 10: Reserved; 11: not support 4KB erase	30H	01:00	01b	E5H
Write Granularity	0: 1Byte, 1: 64Byte or larger		02	1b	
Write Enable Instruction Requested for Writing to Volatile Status Registers	0: Nonvolatile status bit; 1: Volatile status bit (BP status register bit)		03	0b	
Write Enable Opcode Select for Writing to Volatile Status Registers	0: Use 50H Opcode, 1: Use 06H Opcode, Note: If target flash status register is Nonvolatile, then bits 3 and 4 must be set to 00b.		04	0b	
Unused	Contains 111b and can never be changed		07:05	111b	
4KB Erase Opcode		31H	15:08	20H	20H
(1-1-2) Fast Read	0=Not support, 1=Support	32H	16	1b	F1H
Address Bytes Number used in addressing flash array	00: 3Byte only, 01: 3 or 4Byte, 10: 4Byte only, 11: Reserved		18:17	00b	
Double Transfer Rate (DTR) clocking	0=Not support, 1=Support		19	0b	
(1-2-2) Fast Read	0=Not support, 1=Support		20	1b	
(1-4-4) Fast Read	0=Not support, 1=Support		21	1b	
(1-1-4) Fast Read	0=Not support, 1=Support		22	1b	
Unused			23	1b	
Unused		33H	31:24	FFH	FFH
Flash Memory Density		37H:34H	31:00	007FFFFFFH	
(1-4-4) Fast Read Number of Wait states	00000b: Wait states (Dummy Clocks) not support	38H	04:00	00100b	44H
(1-4-4) Fast Read Number of Mode Bits	000b: Mode Bits not support		07:05	010b	
(1-4-4) Fast Read Opcode		39H	15:08	EBH	EBH
(1-1-4) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	3AH	20:16	01000b	08H
(1-1-4) Fast Read Number of Mode Bits	000b: Mode Bits not support		23:21	000b	
(1-1-4) Fast Read Opcode		3BH	31:24	6BH	6BH
(1-1-2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	3CH	04:00	01000b	08H
(1-1-2) Fast Read Number of Mode Bits	000b: Mode Bits not support		07:05	000b	
(1-1-2) Fast Read Opcode		3DH	15:08	3BH	3BH
(1-2-2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	3EH	20:16	00000b	80H
(1-2-2) Fast Read Number of Mode Bits	000b: Mode Bits not support		23:21	100b	
(1-2-2) Fast Read Opcode		3FH	31:24	BBH	BBH

Description	Comment	Add(H) (Byte)	DW Add (Bit)	Data	Data
(2-2-2) Fast Read	0=not support 1=support	40H	00	0b	EEH
Unused			03:01	111b	
(4-4-4) Fast Read	0=not support 1=support		04	0b	
Unused			07:05	111b	
Unused		43H:41H	31:08	0xFFH	0xFFH
Unused		45H:44H	15:00	0xFFH	0xFFH
(2-2-2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	46H	20:16	00000b	00H
(2-2-2) Fast Read Number of Mode Bits	000b: Mode Bits not support		23:21	000b	
(2-2-2) Fast Read Opcode		47H	31:24	FFH	FFH
Unused		49H:48H	15:00	0xFFH	0xFFH
(4-4-4) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	4AH	20:16	00000b	00H
(4-4-4) Fast Read Number of Mode Bits	000b: Mode Bits not support		23:21	000b	
(4-4-4) Fast Read Opcode		4BH	31:24	FFH	FFH
Sector Type 1 Size	Sector/block size=2 ^N Bytes 0x00b: this sector type don't exist	4CH	07:00	0CH	0CH
Sector Type 1 erase Opcode		4DH	15:08	20H	20H
Sector Type 2 Size	Sector/block size=2 ^N Bytes 0x00b: this sector type don't exist	4EH	23:16	0FH	0FH
Sector Type 2 erase Opcode		4FH	31:24	52H	52H
Sector Type 3 Size	Sector/block size=2 ^N Bytes 0x00b: this sector type don't exist	50H	07:00	10H	10H
Sector Type 3 erase Opcode		51H	15:08	D8H	D8H
Sector Type 4 Size	Sector/block size=2 ^N Bytes 0x00b: this sector type don't exist	52H	23:16	0AH	0AH
Sector Type 4 erase Opcode		53H	31:24	8BH	8BH

Table 5. Parameter Table (1): Flash Parameter Tables

Description	Comment	Add(H) (Byte)	DW Add (Bit)	Data	Data
VCC Supply Maximum Voltage	2000H=2.000V 2700H=2.700V 3600H=3.600V	61H:60H	15:00	3600H	3600H
VCC Supply Minimum Voltage	1650H=1.650V 2250H=2.250V 2300H=2.300V 2700H=2.700V	63H:62H	31:16	2700H	2700H
HW RESET pin	0=not support 1=support	65H:64H	00	0b	F99EH
HW HOLD pin	0=not support 1=support		01	1b	
Deep Power Down Mode	0=not support 1=support		02	1b	
SW Reset	0=not support 1=support		03	1b	
SW Reset Opcode	Should be issue Reset Enable(66H) before Reset cmd.		11:04	99H	
Program Suspend/Resume	0=not support 1=support		12	1b	
Erase Suspend/Resume	0=not support 1=support		13	1b	
Unused			14	1b	
Wrap-Around Read mode	0=not support 1=support		15	1b	
Wrap-Around Read mode Opcode		66H	23:16	77H	77H
Wrap-Around Read data length	08H:support 8B wrap-around read 16H:8B & 16B 32H:8B & 16B & 32B 64H:8B & 16B & 32B & 64B	67H	31:24	64H	64H
Individual block lock	0=not support 1=support	6BH:68H	00	0b	EBFCH
Individual block lock bit (Volatile/Nonvolatile)	0=Volatile 1=Nonvolatile		01	0b	
Individual block lock Opcode			09:02	FFH	
Individual block lock Volatile protect bit default protect status	0=protect 1=unprotect		10	0b	
Secured OTP	0=not support 1=support		11	1b	
Read Lock	0=not support 1=support		12	0b	
Permanent Lock	0=not support 1=support		13	1b	
Unused			15:14	11b	
Unused			31:16	FFFFH	FFFFH

ELECTRICAL CHARACTERISTICS

Power-On/Down and Voltage Drop Timing

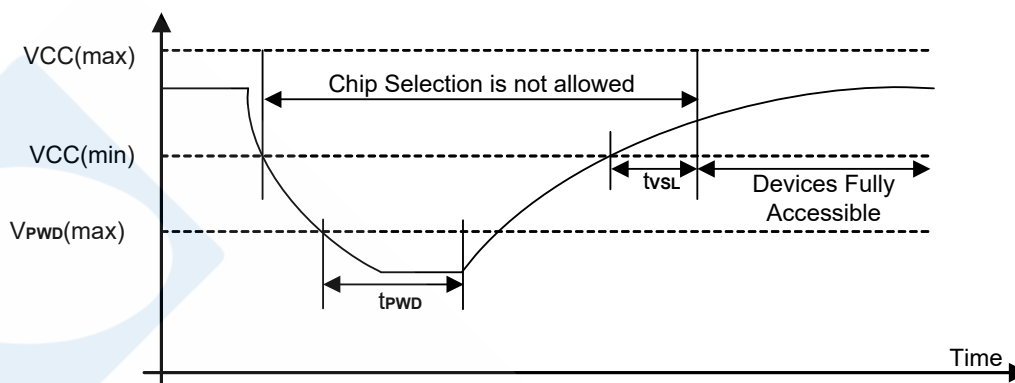


Table 6. Power-Up /Power-Down Timing and Write Inhibit Threshold

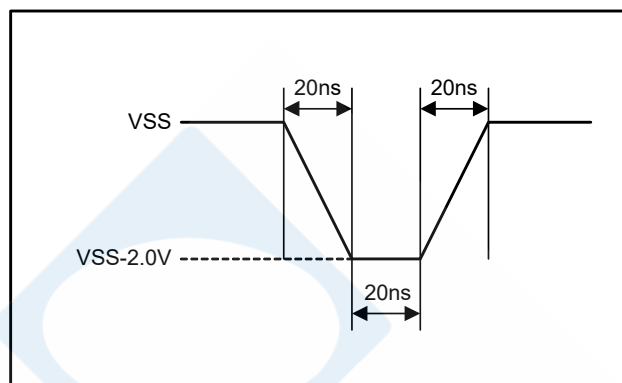
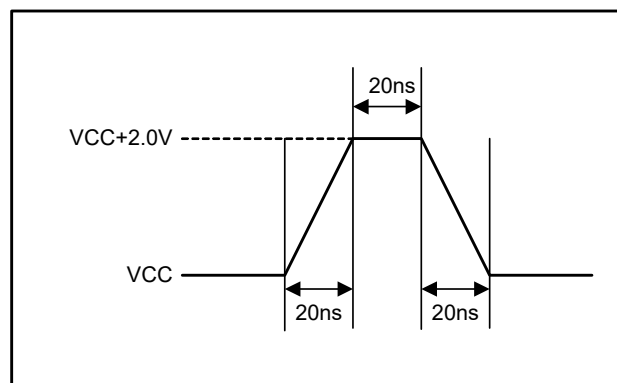
Symbol	Parameter	Min.	Max.	Unit
V_{PWD}	VCC voltage needed to below V_{PWD} for ensuring initialization will occur		1	V
t_{PWD}	The minimum duration for ensuring initialization will occur	300		μs
t_{vSL}	VCC (min) To \bar{S} Low	50	500	μs
V_{WI}	Write Inhibit Voltage	1.5	2.5	V

INITIAL DELIVERY STATE

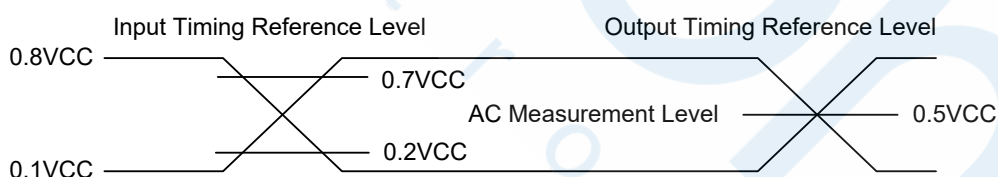
The device is delivered with the memory array erased: all bits are set to 1 (each Byte contains FFH). The Status Register contains 00H (all Status Register bits are 0).

ABSOLUTE MAXIMUM RATINGS

Parameter	Value	Unit
Ambient Operating Temperature	-40 to 85	$^{\circ}C$
Storage Temperature	-65 to 150	$^{\circ}C$
Applied Input / Output Voltage	-0.6 to $V_{CC}+0.4$	V
Transient Input / Output Voltage (note: overshoot)	-2.0 to $V_{CC}+2.0$	V
VCC	-0.6 to 4.2	V

Figure 42. Maximum Negative and Positive Overshoot Waveform

Maximum Negative Overshoot Waveform

Maximum Positive Overshoot Waveform
CAPACITANCE MEASUREMENT CONDITIONS

Symbol	Parameter	Min.	Typ.	Max.	Unit	Conditions
C_{IN}	Input Capacitance			6	pF	$V_{IN}=0V$
C_{OUT}	Output Capacitance			8	pF	$V_{OUT}=0V$
C_L	Load Capacitance	30			pF	
	Input Rise And Fall time			5	ns	
	Input Pulse Voltage	0.1VCC to 0.8VCC			V	
	Input Timing Reference Voltage	0.2VCC to 0.7VCC			V	
	Output Timing Reference Voltage	0.5VCC			V	

Figure 43: Input Test Waveform and Measurement Level


Note: Input pulse rise and fall time are < 5ns

DC CHARACTERISTICS

($T_A = -40^{\circ}\text{C} \sim +85^{\circ}\text{C}$, $V_{CC} = 2.7\text{V} \sim 3.6\text{V}$)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit.
I_{LI}	Input Leakage Current				± 2	μA
I_{LO}	Output Leakage Current				± 2	μA
I_{CC1}	Standby Current	$\bar{S} = V_{CC}$, $V_{IN} = V_{CC}$ or V_{SS}		8		μA
I_{CC2}	Deep Power-Down Current	$\bar{S} = V_{CC}$, $V_{IN} = V_{CC}$ or V_{SS}		0.65	22	μA
I_{CC3}	Operating Current (0B Read)	CLK=0.1VCC / 0.9VCC at 104MHz, Q=Open(*1,*2,*4 I/O)		2.5	3.5	mA
		CLK=0.1VCC / 0.9VCC at 80MHz, Q=Open(*1,*2,*4 I/O)		2.1	3.4	mA
I_{CC4}	Operating Current (PP)	$\bar{S} = V_{CC}$			1.3	mA
I_{CC5}	Operating Current (WRSR)	$\bar{S} = V_{CC}$			1.3	mA
I_{CC6}	Operating Current (SE)	$\bar{S} = V_{CC}$			1.2	mA
I_{CC7}	Operating Current (BE)	$\bar{S} = V_{CC}$			1.2	mA
I_{CC8}	Operating Current (CE)	$\bar{S} = V_{CC}$			1.2	mA
V_{IL}	Input Low Voltage				0.2VCC	V
V_{IH}	Input High Voltage		0.7VCC			V
V_{OL}	Output Low Voltage	$I_{OL} = 100\mu\text{A}$			0.2	V
V_{OH}	Output High Voltage	$I_{OH} = -100\mu\text{A}$	VCC-0.2			V

Note:

1. Typical values given for $T_A = 25^{\circ}\text{C}$.
2. Value guaranteed by design and/or characterization, not 100% tested in production.

AC CHARACTERISTICS

(T_A = -40°C ~ +85°C, VCC= 2.7V ~ 3.6V, C_L= 30pF)

Symbol	Parameter	Min.	Typ.	Max.	Unit.
f _c	Serial Clock Frequency For: Dual I/O(BBH), Quad I/O (EBH), Quad Output (6BH), on 3.0V-3.6V power supply			104	MHz
f _{c1}	Serial Clock Frequency For: Dual I/O(BBH), Quad I/O (EBH), Quad Output (6BH), on 2.7V-3.0V power supply			104	MHz
f _{r0}	Serial Clock Frequency For: Read ID (90H, 9FH and ABH), ReadStatus Register (05H and 35H)			104	MHz
f _{r1}	Serial Clock Frequency For: Read (03H)			55	MHz
t _{CLH}	Serial Clock High Time	4.5			ns
t _{CLL}	Serial Clock Low Time	4.5			ns
t _{CLCH}	Serial Clock Rise Time (Slew Rate)	0.1			V/ns
t _{CHCL}	Serial Clock Fall Time (Slew Rate)	0.1			V/ns
t _{SLCH}	\bar{S} Active Setup Time	5			ns
t _{CHSH}	\bar{S} Active Hold Time	5			ns
t _{SHCH}	\bar{S} Not Active Setup Time	5			ns
t _{CHSL}	\bar{S} Not Active Hold Time	5			ns
t _{SHSL}	\bar{S} High Time (Read/Write)	20			ns
t _{SHQZ}	Output Disable Time			6	ns
t _{CLQX}	Output Hold Time	1.2			ns
t _{DVCH}	Data In Setup Time	2			ns
t _{CHDX}	Data In Hold Time	2			ns
t _{HLCH}	\overline{HOLD} Low Setup Time (Relative To Clock)	5			ns
t _{HHCH}	\overline{HOLD} High Setup Time (Relative To Clock)	5			ns
t _{CHHL}	\overline{HOLD} High Hold Time (Relative To Clock)	5			ns
t _{CHHH}	\overline{HOLD} Low Hold Time (Relative To Clock)	5			ns
t _{HLQZ}	\overline{HOLD} Low To High-Z Output			6	ns
t _{HHQX}	\overline{HOLD} High To Low-Z Output			6	ns
t _{CLQV}	Clock Low To Output Valid			7	ns
t _{WHSL}	Write Protect Setup Time Before \bar{S} Low	20			ns
t _{SHWL}	Write Protect Hold Time After \bar{S} High	100			ns
t _{DP}	\bar{S} High To Deep Power-Down Mode			25	μs
t _{RES1}	\bar{S} High To Standby Mode Without Electronic Signature Read			25	μs
t _{RES2}	\bar{S} High To Standby Mode With Electronic Signature Read			25	μs
t _{SUS}	\bar{S} High To Next Command After Suspend			20	μs
t _{RS}	Latency Between Resume And Next Suspend	100			μs
t _{RST}	\bar{S} High To Next Command After Reset (Except From WRSR, Chip Erase)			30	μs
	\bar{S} High To Next Command After Reset (From Chip Erase)			120	μs
	\bar{S} High To Next Command After Reset (From WRSR)			4	ms

AC CHARACTERISTICS (Continued)

(T_A = -40°C ~ +85°C, VCC= 2.7V ~ 3.6V, C_L= 30pF)

Symbol	Parameter	Min.	Typ.	Max.	Unit.
t _W	Write Status Register Cycle Time		3.5	4	ms
t _{BP1}	Byte Program Time (First Byte)		60	75	μs
t _{BP2}	Additional Byte Program Time (After First Byte)		10	15	μs
t _{PP}	Page Programming Time		1.5	2	ms
t _{SE}	Sector Erase Time (4K Bytes)		3.5	4	ms
t _{BE1}	Block Erase Time (32K Bytes)		3.5	4	ms
t _{BE2}	Block Erase Time (64K Bytes)		3.5	4	ms
t _{CE}	Chip Erase Time (A25LQ080A)		6	8	ms

Note:

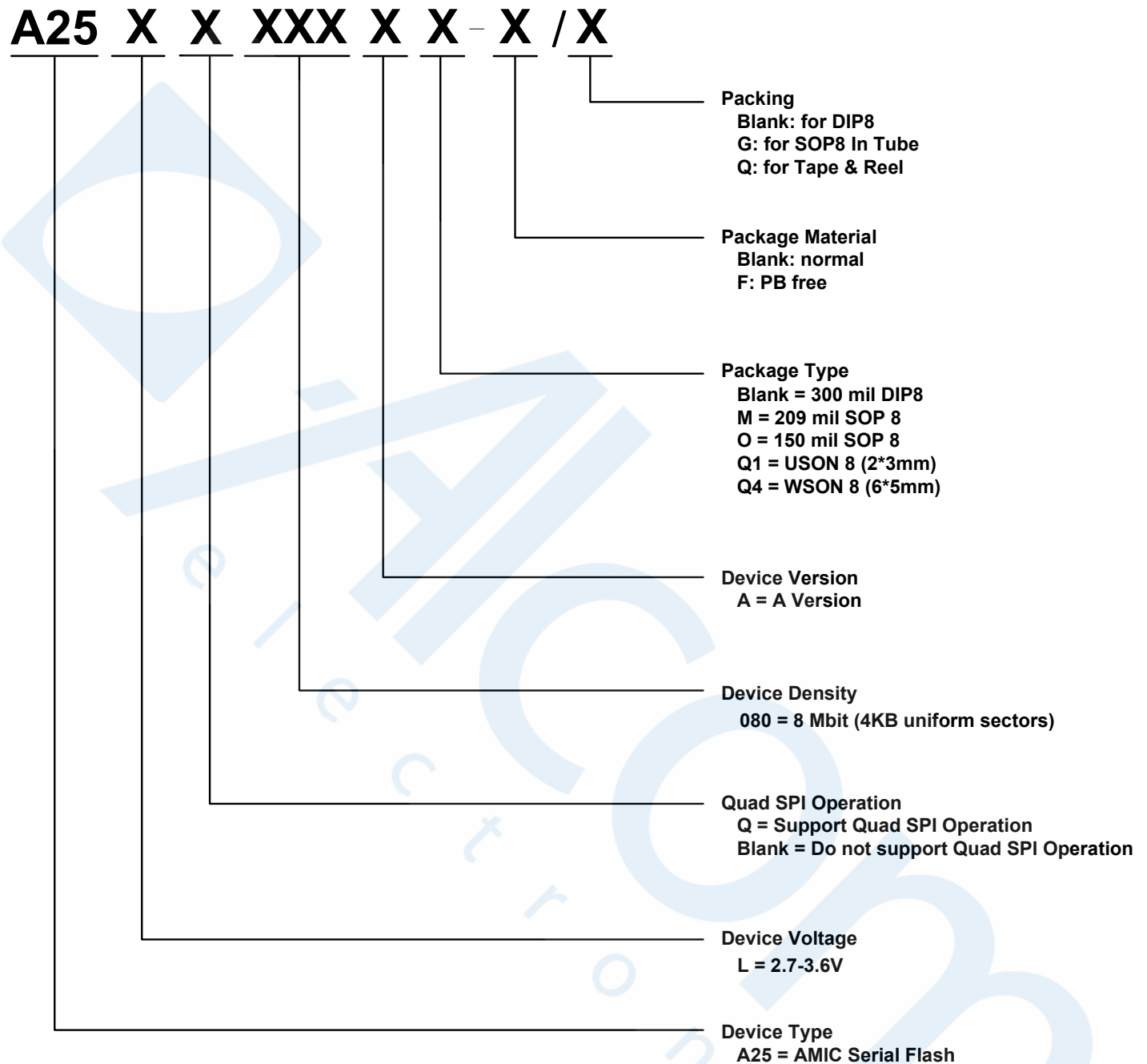
1. Typical values given for T_A=25°C.
2. Value guaranteed by design and/or characterization, not 100% tested in production.



The timing diagram illustrates the relationship between the \overline{S} (Strobe), C (Clock), DI (Data Input), and DQ (Data Output) signals. The DQ signal is shown in a High-Z state during the DI phase. Key timing parameters are labeled:

- t_{CHSL} : Strobe-to-clock setup time.
- t_{SLCH} : Strobe-to-clock hold time.
- t_{CLH} : Clock-to-data input setup time.
- t_{CLL} : Clock-to-data input hold time.
- t_{DVCH} : Data valid-to-clock setup time.
- t_{CHDX} : Clock-to-data output delay.
- t_{CHSH} : Clock-to-strobe hold time.
- t_{SHSL} : Strobe-to-strobe setup time.
- t_{SHCH} : Strobe-to-strobe hold time.
- t_{CLCH} : Clock-to-data output setup time.
- t_{CHCL} : Clock-to-data output hold time.

DI do not care during HOLD operation

Part Numbering Scheme


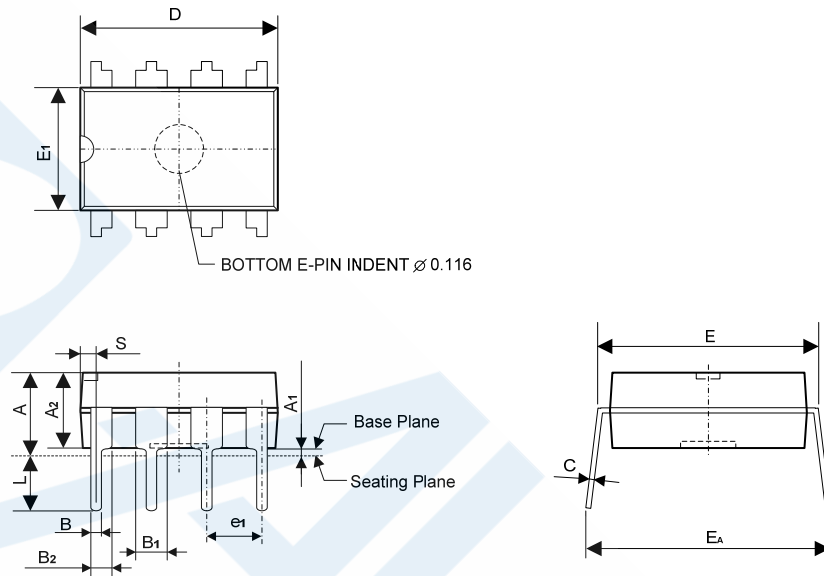
Ordering Information

Part No.	Speed (MHz)	Active Read Current Max. (mA)	Program/Erase Current Max. (mA)	Standby Current Max. (μ A)	Package
A25LQ080A-F	104	3.7	1.3	8	8 Pin Pb-Free DIP (300 mil)
A25LQ080AO-F					8 Pin Pb-Free SOP (150mil)
A25LQ080AM-F					8 Pin Pb-Free SOP (209mil)
A25LQ080AQ1-F					8 Pin Pb-Free USON (2*3mm)
A25LQ080AQ4-F					8 Pin Pb-Free WSON (6*5mm)

Operating temperature range: -40°C ~ +85°C.

Package Information
P-DIP 8L Outline Dimensions

unit: inches/mm



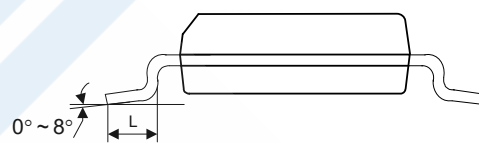
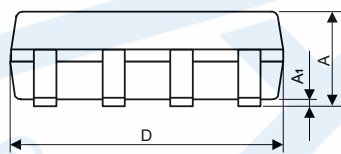
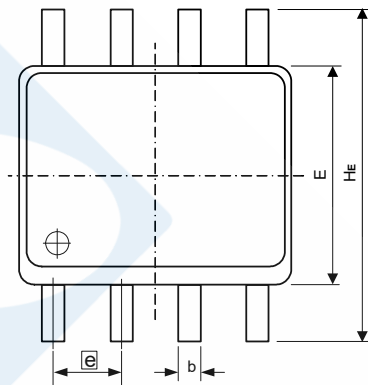
Symbol	Dimensions in inches			Dimensions in mm		
	Min	Nom	Max	Min	Nom	Max
A	-	-	0.180	-	-	4.57
A ₁	0.015	-	-	0.38	-	-
A ₂	0.128	0.130	0.136	3.25	3.30	3.45
B	0.014	0.018	0.022	0.36	0.46	0.56
B ₁	0.050	0.060	0.070	1.27	1.52	1.78
B ₂	0.032	0.039	0.046	0.81	0.99	1.17
C	0.008	0.010	0.013	0.20	0.25	0.33
D	0.350	0.360	0.370	8.89	9.14	9.40
E	0.290	0.300	0.315	7.37	7.62	8.00
E ₁	0.254	0.260	0.266	6.45	6.60	6.76
e ₁	-	0.100	-	-	2.54	-
L	0.125	-	-	3.18	-	-
E _A	0.345	-	0.385	8.76	-	9.78
S	0.016	0.021	0.026	0.41	0.53	0.66

Notes:

1. Dimension D and E₁ do not include mold flash or protrusions.
2. Dimension B₁ does not include dambar protrusion.
3. Tolerance: ±0.010" (0.25mm) unless otherwise specified.

Package Information
SOP 8L (150mil) Outline Dimensions

unit: mm



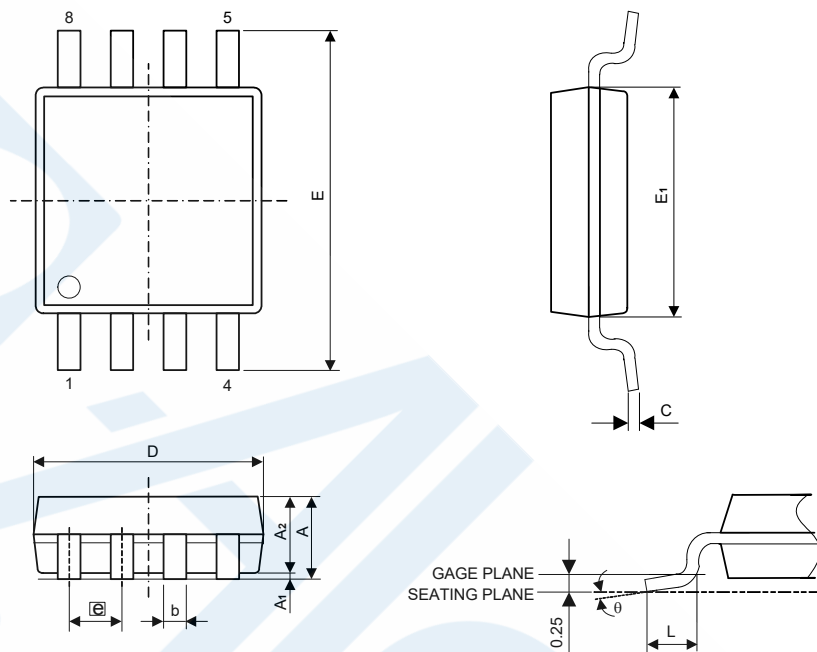
Symbol	Dimensions in mm
A	1.35~1.75
A ₁	0.10~0.25
b	0.33~0.51
D	4.7~5.0
E	3.80~4.00
e	1.27 BSC
HE	5.80~6.20
L	0.40~1.27

Notes:

1. Maximum allowable mold flash is 0.15mm.
2. Complies with JEDEC publication 95 MS-012 AA.
3. All linear dimensions are in millimeters (max/min).
4. Coplanarity: Max. 0.1mm

Package Information
SOP 8L (209mil) Outline Dimensions

unit: mm



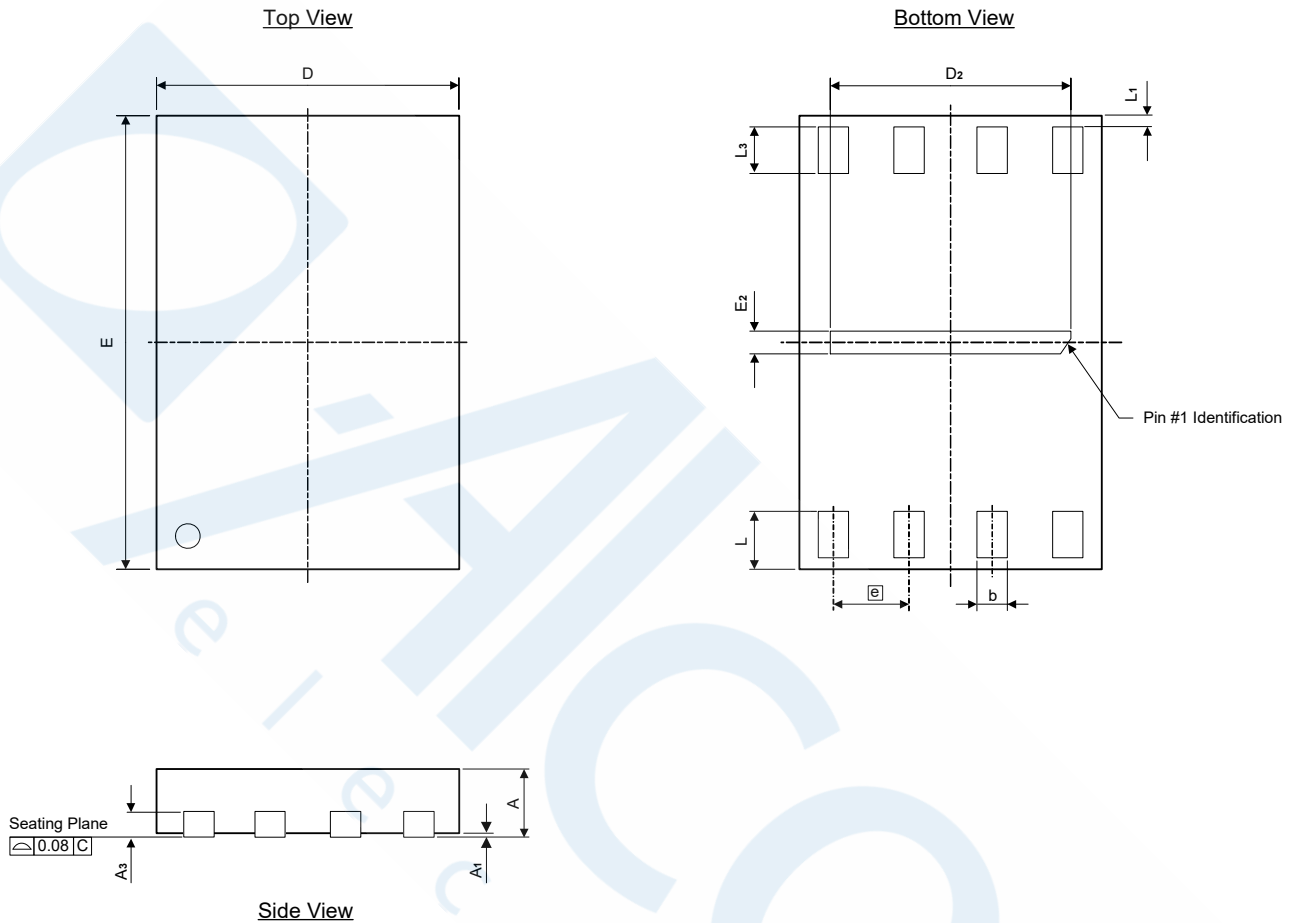
Symbol	Dimensions in mm		
	Min	Nom	Max
A	1.75	1.95	2.16
A1	0.05	0.15	0.25
A2	1.70	1.80	1.91
b	0.35	0.42	0.48
C	0.19	0.20	0.25
D	5.13	5.23	5.33
E	7.70	7.90	8.10
E1	5.18	5.28	5.38
e	1.27 BSC		
L	0.50	0.65	0.80
θ	0°	-	8°

Notes:

Maximum allowable mold flash is 0.15mm at the package ends and 0.25mm between leads

Package Information
USON 8L (2 X 3 X 0.45mm) Outline Dimensions

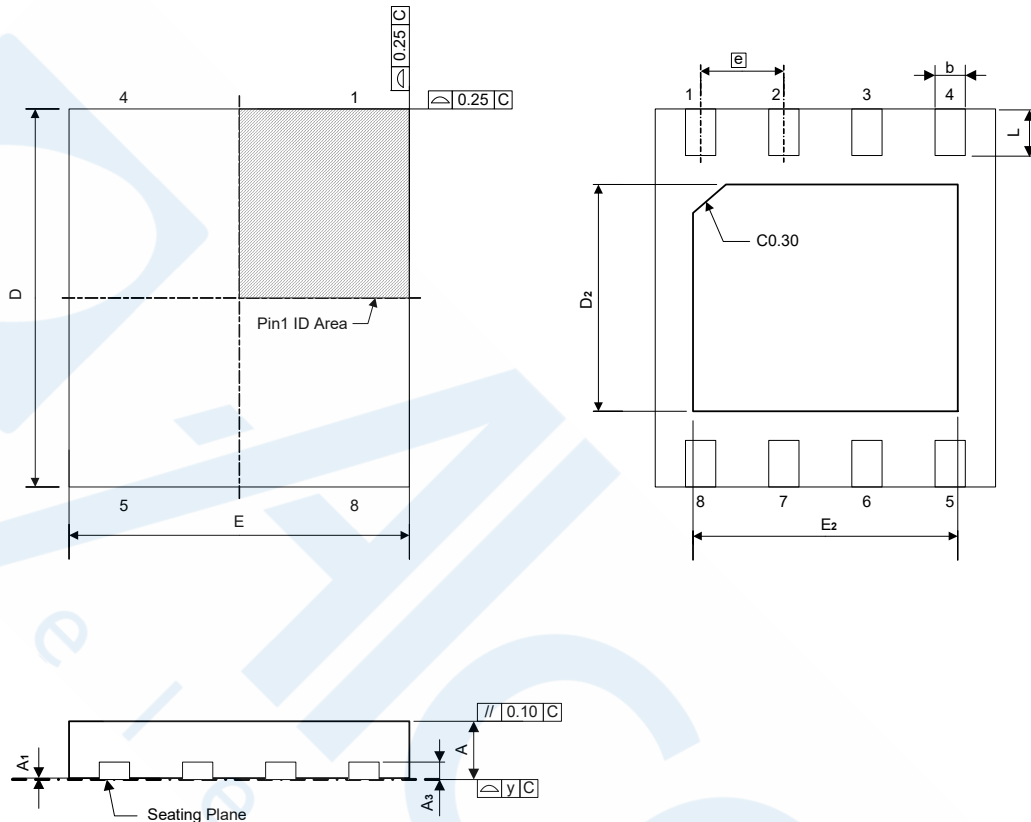
unit: mm



Symbol	Dimensions in mm		
	Min	Nom	Max
A	0.40	0.45	0.50
A ₁	0	0.02	0.05
A ₃	0.20 REF.		
D	1.90	2.00	2.10
D ₂	1.45	1.55	1.65
E	2.90	3.00	3.10
E ₂	0.10	0.20	0.30
e	0.50 BASIC		
b	0.20	0.25	0.30
L	0.40	0.45	0.50
L ₁	0.10 REF.		
L ₃	0.30	0.35	0.40

Package Information
WSO8 8L (6 X 5 X 0.8mm) Outline Dimensions

unit: mm/mil



Symbol	Dimensions in mm			Dimensions in mil		
	Min	Nom	Max	Min	Nom	Max
A	0.700	0.750	0.800	27.6	29.5	31.5
A1	0.000	0.020	0.050	0.0	0.8	2.0
A3	0.203 REF			8.0 REF		
b	0.350	0.400	0.480	13.8	15.8	18.9
D	5.900	6.000	6.100	232.3	236.2	240.2
D2	3.200	3.400	3.600	126.0	133.9	141.7
E	4.900	5.000	5.100	192.9	196.9	200.8
E2	3.800	4.000	4.200	149.6	157.5	165.4
L	0.500	0.600	0.750	19.7	23.6	29.5
e	1.270 BSC			50.0 BSC		
y	0	-	0.080	0	-	3.2

Note:

1. Controlling dimension: millimeters
2. Leadframe thickness is 0.203mm (8mil)